



Lenovo UEFI Diagnostics

Bootable Version - x64

v04.43.000



FIT - Flextronics Institute of Technology

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Contents

1	Introduction	6
2	Install the Lenovo UEFI Diagnostics	6
2.1	Step 1: Download the Required Files	6
2.2	Step 2: Create a Bootable USB Flash Drive	6
2.3	Step 3: Running the UEFI Diagnostics	6
3	Privacy Policy	6
4	Application Overview	8
4.1	Navigation	8
4.2	Interface Components	8
5	Module Diagnostic	10
5.1	Execution Flow	10
5.1.1	Select Device	10
5.1.2	Select Algorithm	12
5.1.3	Main Execution	13
5.1.4	Diagnostic Result and Log	14
5.2	Attended Diagnostics	16
6	Run All Diagnostics	17
6.1	Run All Options	17
6.2	Run All Execution Flow	18
7	Modules and Diagnostics	20
7.1	Audio	21
7.2	Battery	21
7.2.1	Battery Diagnostic Interactions	21
7.3	CPU	22
7.4	Display	22
7.4.1	Display Diagnostic Interactions	23
7.5	FAN	24
7.6	Keyboard	25
7.6.1	Keyboard Diagnostic Interactions	25
7.7	Memory	26
7.8	Motherboard	27
7.8.1	Motherboard Diagnostic Interactions	27
7.9	Mouse	28
7.9.1	Mouse Diagnostic Interactions	28
7.10	Optical	29
7.11	Raid	30
7.12	Sensor	30
7.12.1	Sensor Diagnostic Interactions	30
7.13	Storage	31
7.14	Touch	32
7.14.1	Touch Diagnostic Interactions	32
7.15	Wired Ethernet	34
8	Lenovo UEFI Tools	34
8.1	Available Tools	35
8.1.1	System Information	35
8.1.2	Bad Block Recovery	36
8.1.3	Hardware Diagnostic Events	39
8.1.4	Data Disposal	39
8.1.5	SMART Information	41
8.1.6	FAN Speed	42

9 Features	43
9.1 Times to Run	43
9.2 Screenshot Button	46
9.3 Help Button	46
9.4 Hierarchical diagnostics	47
10 Exit the application	48

List of Figures

1	Privacy Policy Menu	7
2	QR Code Result	7
3	Home Screen Lenovo UEFI	8
4	Lenovo Header	9
5	Lenovo Footer	9
6	Lenovo Footer - PgUp/PgDn and Home buttons	9
7	Lenovo UEFI Screen Layout	9
8	Lenovo Diagnostics Section	10
9	Device Selection Screen	11
10	Select the "i" option	11
11	Device Additional Information	12
12	Algorithm Selection Screen	12
13	Algorithm Selection Screen Run Button	13
14	Diag Execution Screen Layout	13
15	Diagnostic Result Screen	14
16	View Log Screen	15
17	Sensitive Information Popup	15
18	Log Successfully Saved Popup	16
19	Attended Execution Example 01	16
20	Attended Execution Example 02	17
21	Run All Button in Home Screen	17
22	Run All Options	18
23	Run All Execution Screen	18
24	Run All Result	19
25	Run All Log	19
26	Lenovo Diagnostics Section	20
27	Connect the charge AC popup	21
28	Display Info Popup	23
29	Example of Combination Test screen	24
30	Display Confirm Popup	24
31	Keyboard Custom Execution Screen	25
32	Keyboard Question Popup	26
33	External Ports Execution Screen	27
34	Custom Mouse Execution Screen	28
35	Mouse Question Popup	29
36	Mouse Precision Test Screen	29
37	Sensor Popup	31
38	Touch Explaining Popup	33
39	Touch Paint Screen Grid Test	33
40	Touch Question Popup	34
41	Tools	35
42	System Information	36
43	Sensitive Popup	36
44	Bad Block Recovery Tool Device Selection	37
45	Bad Block Recovery Tool Algorithm Selection	37
46	Bad Block Recovery Tool Warning	38
47	Bad Block Recovery Execution	38
48	Bad Block Recovery Result	39
49	Hardware Diagnostic Events	39
50	Data Disposal Quick Information	40
51	Data Disposal Full Information	40
52	Data Disposal Full Information	41
53	SMART Information Tool	41
54	SMART Information Tool	42
55	Fan Speed Warning	42
56	Fan Speed Tool	43
57	Times to Run - Module Configuration	44
58	Times to Run - Run All Configuration	44
59	Times to Run Execution Screen	45

60	Times to Run Result Screen	45
61	Times to Run View Log Screen	46
62	Screenshot Button	46
63	Help Popup	47
64	Help Popup	47
65	Hierarchical Popup	48
66	Hierarchical Execution	48
67	Button Exit	49
68	Exit Popup	49

1 Introduction

Lenovo UEFI Diagnostics is a hardware diagnosis tool that enables the users to verify, on their machines, if hardware pieces are presenting problems or malfunctioning, by performing a variety of tests of supported hardware components.

This document describes the main functionalities of the application and how to use them.

2 Install the Lenovo UEFI Diagnostics

2.1 Step 1: Download the Required Files

1. Go to www.Lenovo.com/diags.
2. Select **Downloads**.
3. Under “Lenovo Diagnostics UEFI Bootable Versions,” click **How to Create Bootable USB**.
4. Download the appropriate UEFI Diagnostics ZIP file for your machine’s architecture.
5. Download the **Bootable Generator ZIP file** and follow the installation instructions.

2.2 Step 2: Create a Bootable USB Flash Drive

1. Insert a USB flash drive into your computer.
2. Run **BootableGenerator.exe** from the desktop or Start menu.
3. Under “Select a device,” choose your flash drive. You can rename the drive if needed.
4. Click **Search** and locate the Lenovo Diagnostics Tool file you downloaded earlier.
5. Click **Generate**.
6. A warning will appear stating that all data on the USB will be erased. If this is acceptable, click **Yes** to proceed.

2.3 Step 3: Running the UEFI Diagnostics

1. Insert the prepared USB flash drive into the machine to be diagnosed.
2. Restart the machine and press **F12** during startup to access the boot menu.
3. Select the USB flash drive from the boot menu and press **Enter**.
4. The UEFI diagnostics menu will appear.

3 Privacy Policy

When the user first runs the application, they will be presented with the Privacy Policy menu before accessing the home screen. In this menu, the user will be able to read Lenovo’s privacy policies via a QR Code. It is essential that the user accepts this policy, as the application collects diagnostic and usage data necessary to keep Lenovo’s UEFI application secure, up to date, and to provide troubleshooting and support.



Figure 1: Privacy Policy Menu

Accepting the Privacy Policy is crucial for the full functioning of the application. Without the user's consent, they will not be able to export diagnostic logs or send data to Lenovo. This data is vital for implementing improvements to the UEFI application. Therefore, it is highly recommended that the user accepts the policy to utilize all the features of the application and contribute to its ongoing maintenance and enhancement.

After completing diagnostics, a QR Code will be generated. Once the user scans this QR Code with the policy acceptance, the diagnostic log data and information about their machine will be automatically sent to Lenovo's servers. This data will undergo future analysis, helping to identify areas for improvement and ensuring that the application continues to meet requirements effectively.

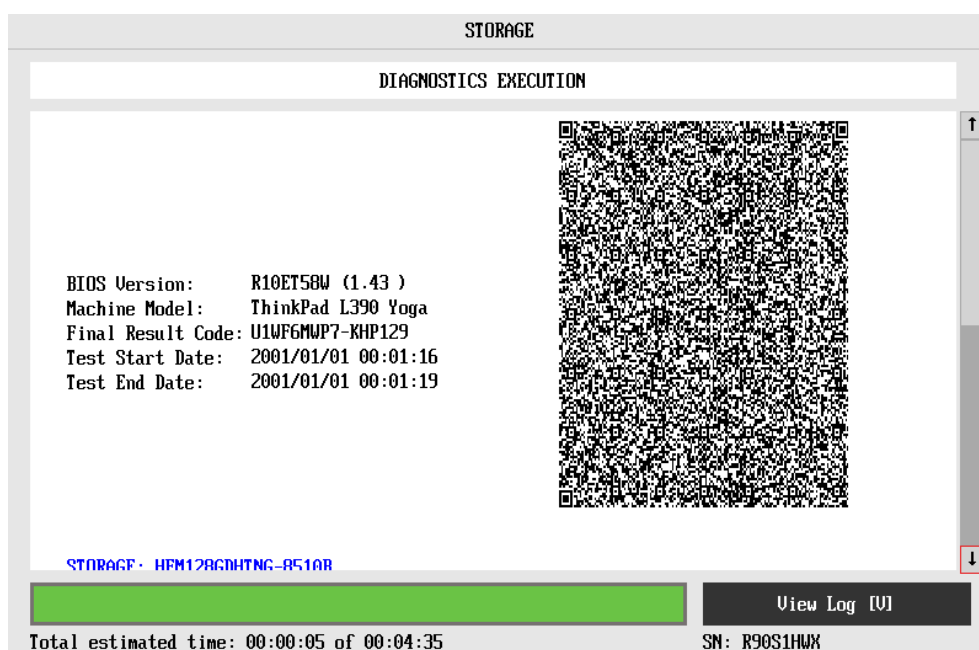


Figure 2: QR Code Result

The user can open the Privacy Policy settings and withdraw their acceptance at any time, at their discretion. By doing so, they will halt data collection and the ability to generate diagnostic logs.

4 Application Overview

When the Lenovo UEFI application starts, the first screen displayed is the home screen, where the user can access all functionalities.

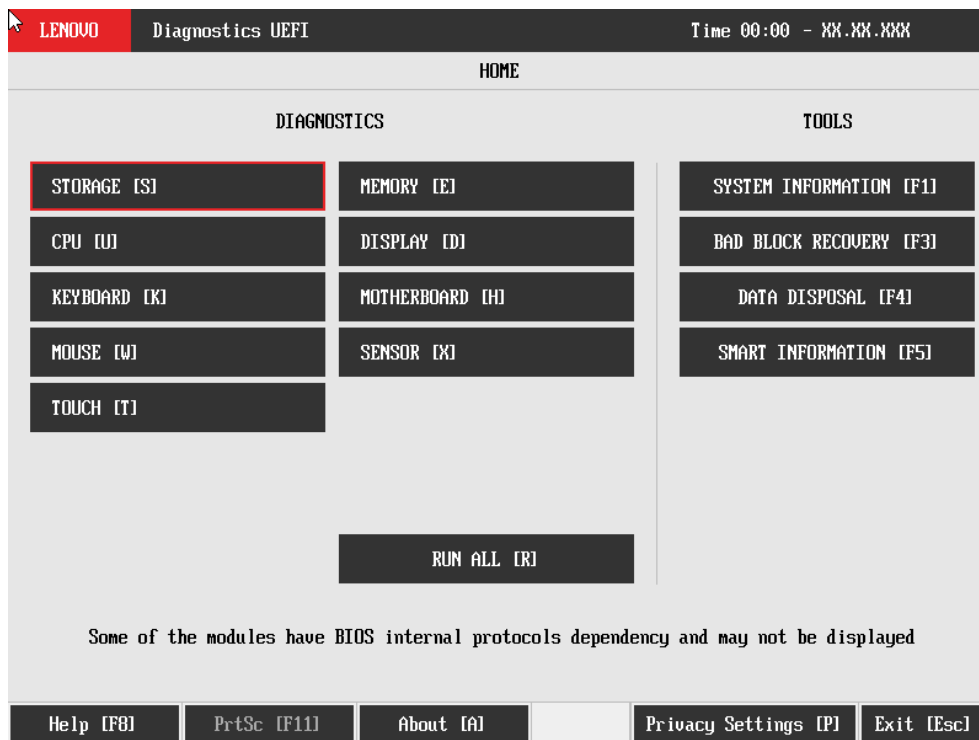


Figure 3: Home Screen Lenovo UEFI

4.1 Navigation

To navigate through the application options, the user can use multiple devices. The selected option will be highlighted in red. To change focus, the user can use a pointing device such as a mouse or touchpad, touch devices if available, or the keyboard arrows and tab key. To select an option, the user can click or touch with the pointing device, or use the enter or space key on the keyboard.

4.2 Interface Components

The Lenovo UEFI application screen layout can be divided into three main sections: the Header, Footer, and Content Area.

The Header displays the application vendor name, which is Lenovo Diagnostics UEFI. It also shows the current system time and the application version. If supported by the system, the header may also display the battery charge level. If this is not shown, it means the feature is not supported. Below the header there will be the current screen name. Check the image below.



Figure 4: Lenovo Header

The Footer provides the user with navigation tips and buttons. The content of the footer can change depending on the screen the user is viewing. If the user is on the home screen, the buttons are: Help, Print Screen, About, Exit and Privacy Policy buttons. However, if the user is on a screen with a scrollbar, there will be options for paging up and down, along with corresponding buttons. If the user is not on the home screen, the button that usually indicates "Exit" will change to a "Home" button, allowing the user to return to the home screen. See the footer options below.



Figure 5: Lenovo Footer



Figure 6: Lenovo Footer - PgUp/PgDn and Home buttons

The Content Area is where the user interacts with the application. It displays the options available on the current page. Each application feature will be explained in future chapters. The content area will show users what they can interact with, such as listing modules, executing diagnostics, checking logs, and more. For the Home Screen, the content area will display all the modules currently supported by the application, allowing the user to access these modules to perform diagnostics on system components.

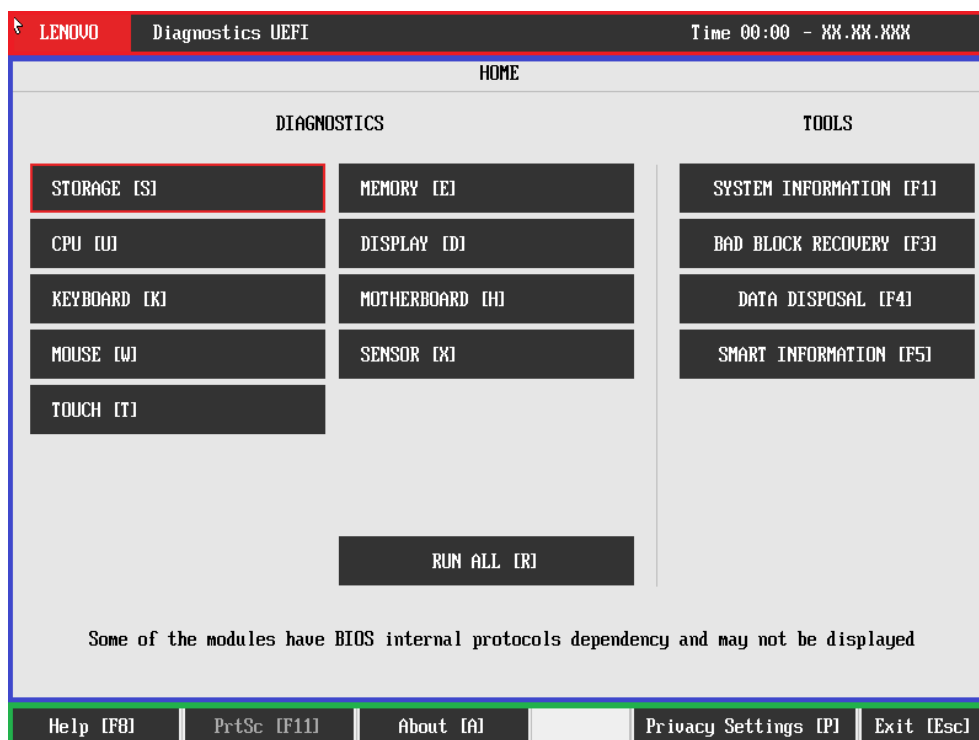


Figure 7: Lenovo UEFI Screen Layout

● Header ● Content ● Footer

5 Module Diagnostic

To perform a diagnostic, the user must first select a module from the Diagnostics section. All available modules are displayed on the Home Screen. Each module represents a device supported by the machine, but not all modules are available for every machine due to certain BIOS protocol requirements. If these protocols are missing, the module will not be accessible. Each module contains a set of diagnostics specific to the devices in the machine.

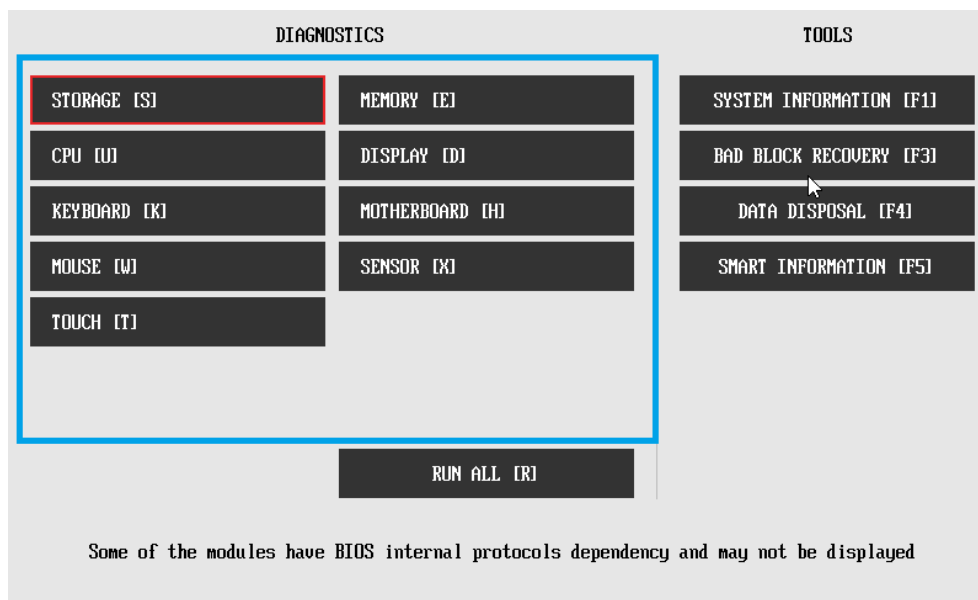


Figure 8: Lenovo Diagnostics Section

● Diagnostics Section

In this section, we will select the Storage module as an example. However, the execution flow is common for all modules.

5.1 Execution Flow

The execution process is similar for all modules, with minor differences for specific ones that will be explained later. This chapter outlines the main steps for most modules.

5.1.1 Select Device

Once the module is chosen, the next step is to select a device for the diagnostic. This is done on the Device Selection Screen, where all available devices for that module are listed.

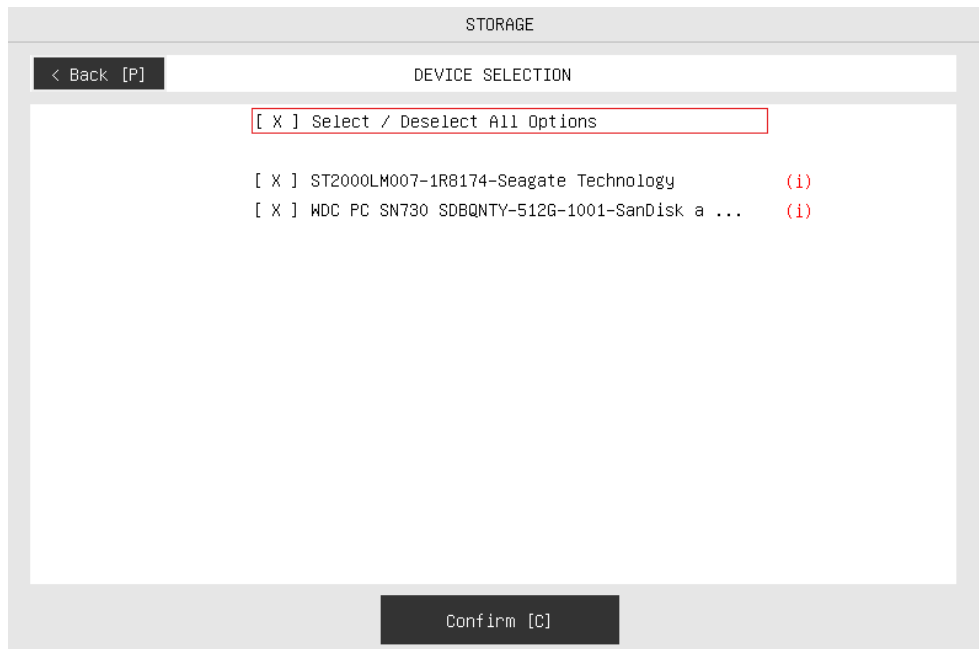


Figure 9: Device Selection Screen

For some modules, an "i" option may appear next to the device name, allowing the user to view more information about the device by pressing the "i" key or selecting the button in any way.

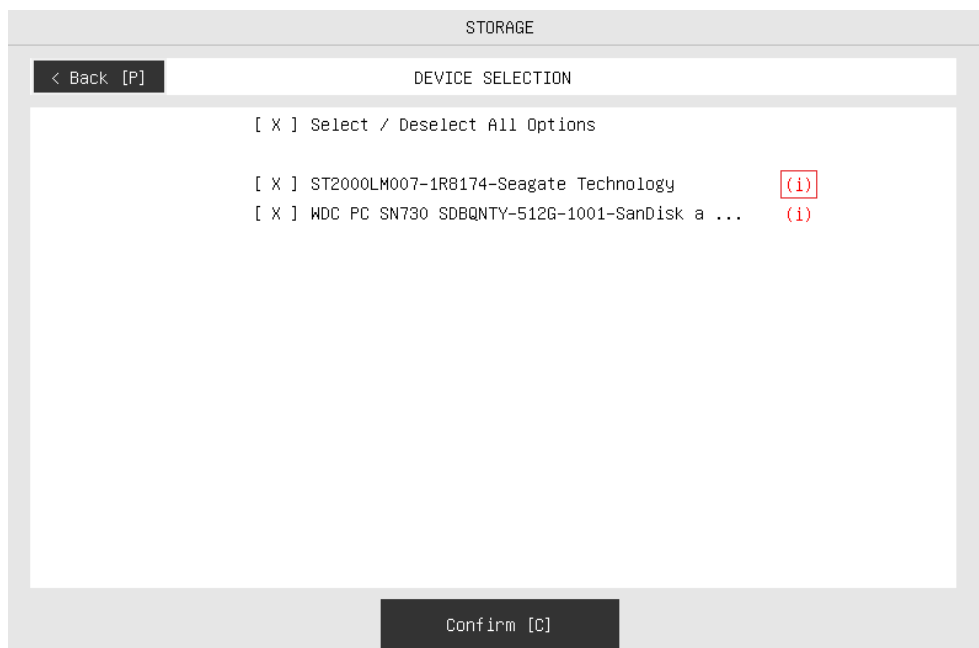


Figure 10: Select the "i" option

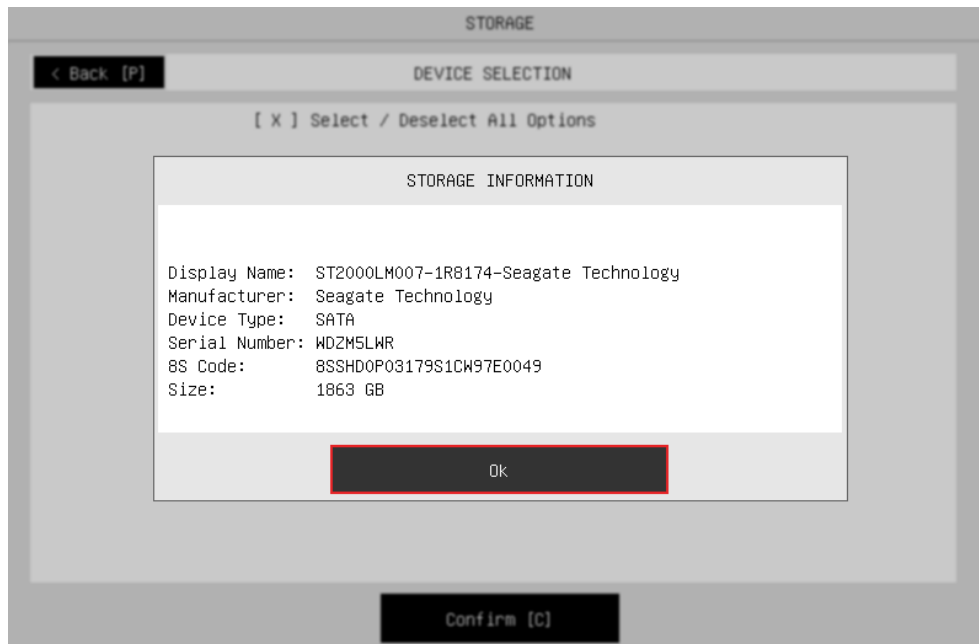


Figure 11: Device Additional Information

5.1.2 Select Algorithm

After the device is selected, the next screen is the Algorithm Selection. Here, the user chooses which algorithms to run. Each algorithm tests different aspects of the selected device. Users can run a single algorithm, all algorithms at once, or select a custom combination. The algorithms are divided between Quick and Extended. The main difference is the time needed to complete the diagnostics; the Quick option is for diagnostics that take less than 10 minutes, while the Extended option is for those that may take longer.

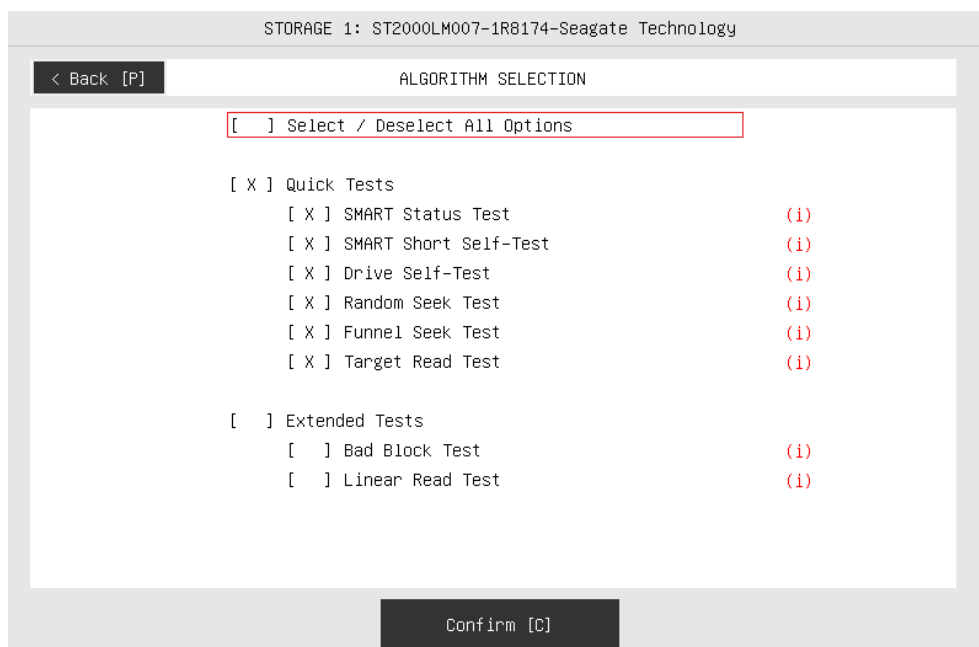


Figure 12: Algorithm Selection Screen

Each device will have a specific Algorithm Selection, and when the user is selecting the diagnostics for the last device, a "Run" button will appear along with a "Times to Run" configuration (explained in the Features section).

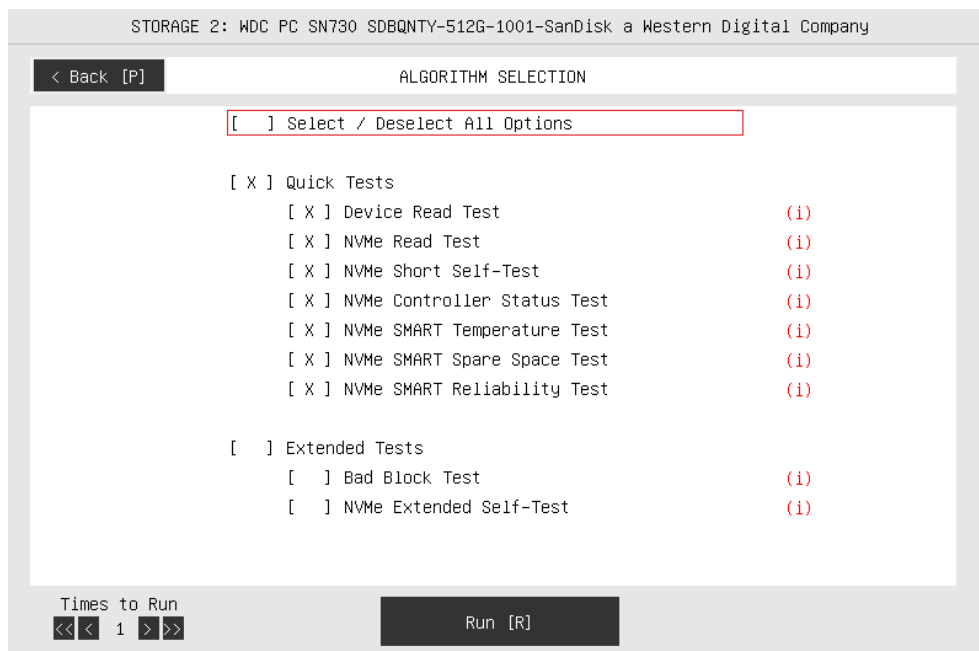


Figure 13: Algorithm Selection Screen Run Button

5.1.3 Main Execution

Once the diagnostics are chosen, the user starts the execution on the Diagnostics Execution Screen, which has three main sections.

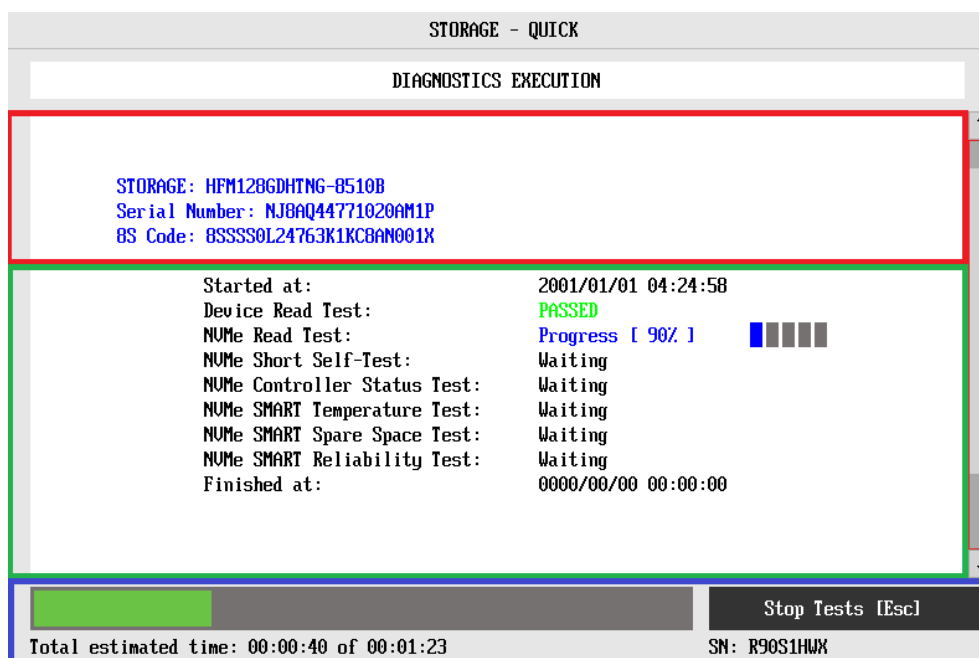


Figure 14: Diag Execution Screen Layout

- Device Information
- Diagnostic information
- Progress information

Device Information: This section shows details about the selected device.

Diagnostics Information: This section shows information about the selected algorithms, including the start time, current percentage of execution, and the status of previous diagnostics.

Progress Information: This section displays a progress bar, an estimated time for completion, and a "Stop Tests" button to cancel the execution.

5.1.4 Diagnostic Result and Log

Once all selected algorithms finish, the next screen is the Diagnostic Result Screen. This screen is similar to the Execution Screen but shows the status of each algorithm, the end time, the QR Code containing some machine information, and a "View Log" button.

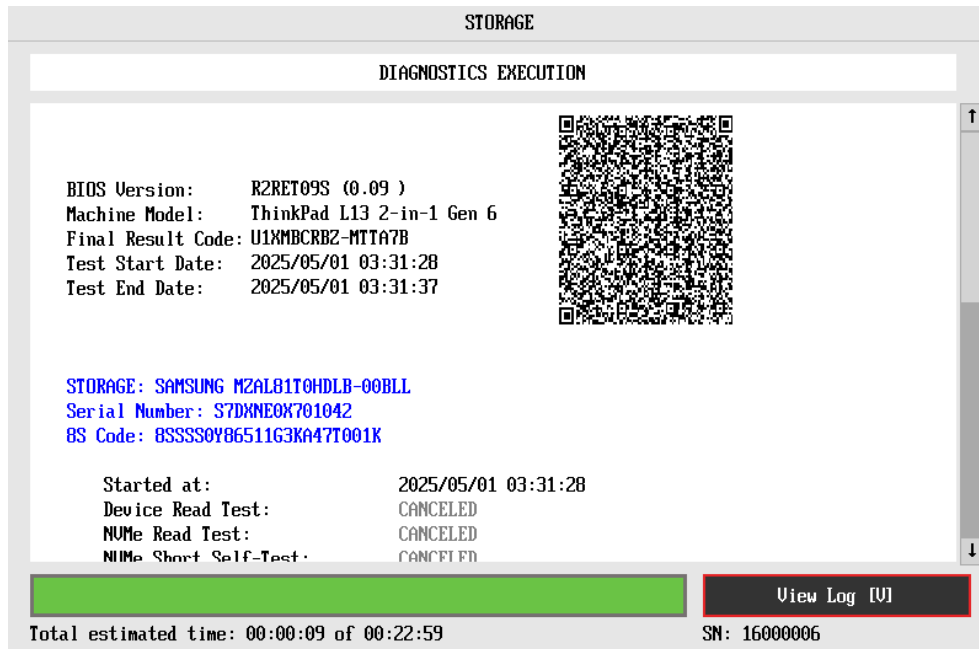


Figure 15: Diagnostic Result Screen

Possible status results include:

- **PASSED** : This status indicates that the algorithm was successfully executed and all validations were met. It means the tested device has no defects in the diagnosed area.
- **FAILED** : This status indicates that the diagnostics could not complete due to unexpected behavior or a malfunction in the device.
- **WARNING** : A warning means the device may have some non-critical issues that need attention, possibly indicating a misconfiguration in the system.
- **CANCELED** : This status is used when the user cancels the execution. It indicates that the process was halted by user action.
- **NOT APPLICABLE** : This status means that the conditions for validating the behavior were not met, making the executed algorithm not applicable.

When clicking the View Log button user is redirect to the Result Log screen, where the diagnostics results are more detailed.

The Result Log Screen provides all information for the selected devices, including a summary of executed diagnostics with start times, names, statuses, and durations.

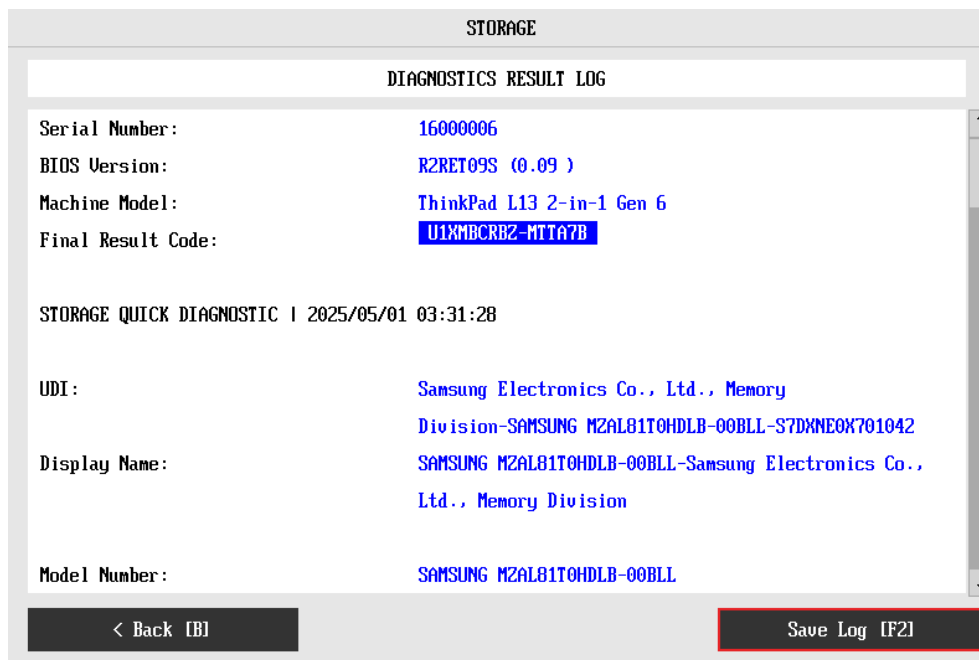


Figure 16: View Log Screen

There is a "Save Log" button that exports a file to a connected flash drive. Before saving, the application will check if the user has accepted the Privacy Policy, in case user didn't accepted, the application warns the policy should be accepted in order to export logs with sensitive information. If the user agrees, the log is saved to the flash drive.

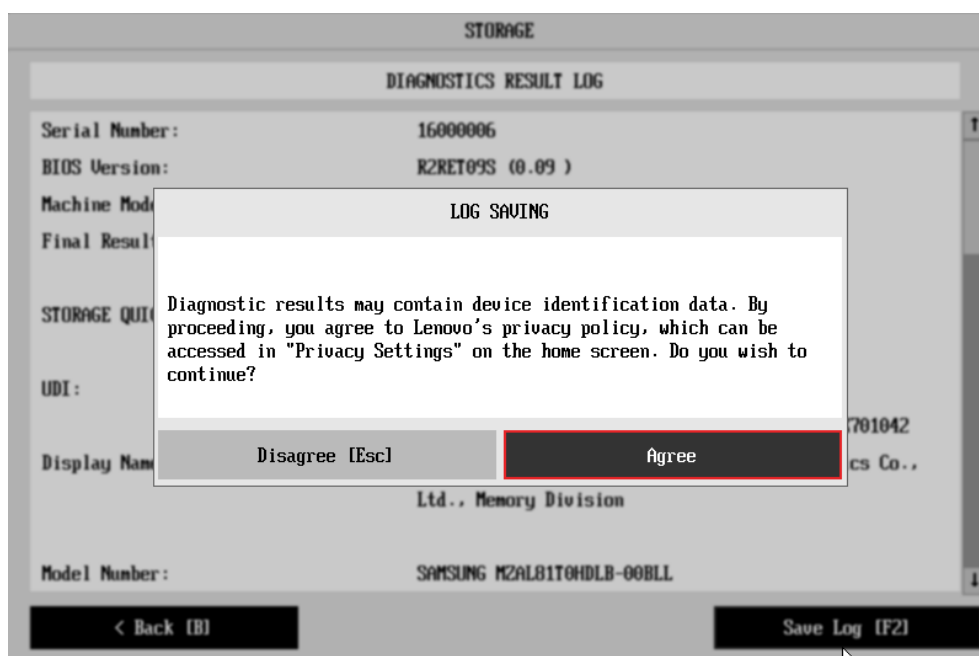


Figure 17: Sensitive Information Popup

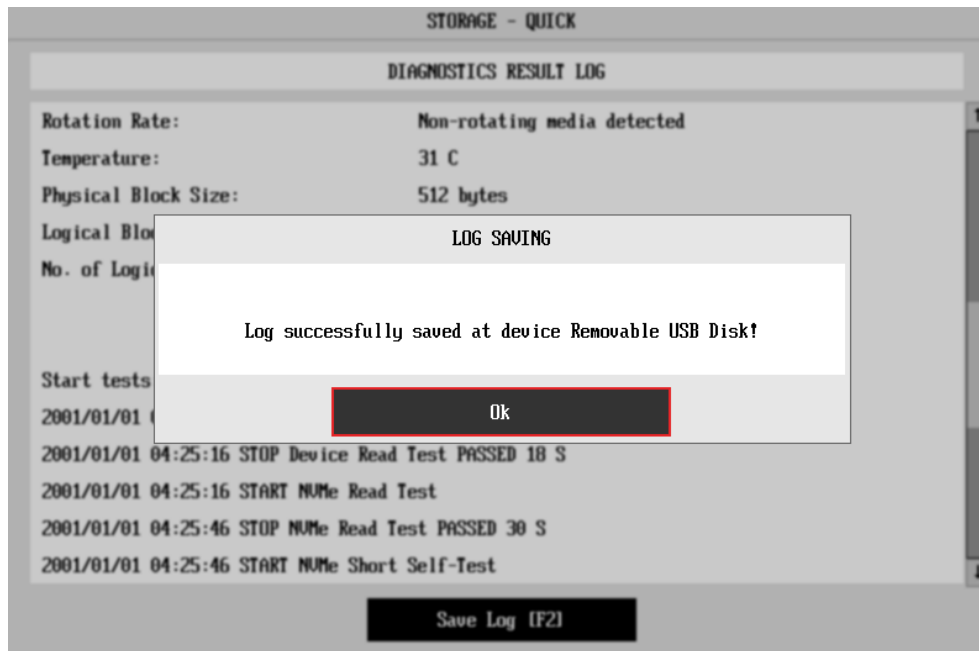


Figure 18: Log Successfully Saved Popup

5.2 Attended Diagnostics

The algorithms in Lenovo UEFI Diagnostics application can be divided into two types of execution, which would be attended and unattended diagnostics. The attended diagnostics are those which need the user interaction to complete and get the results. The attended diagnostics have an execution flow a bit different from the explained above, that's because the Diagnostic Execution Screen is customized so the user can interact with.

Below images show examples of attended tests with the popup information that asks the user to perform certain action. The attended diagnostics flow will be explained for each module in the module specific section.

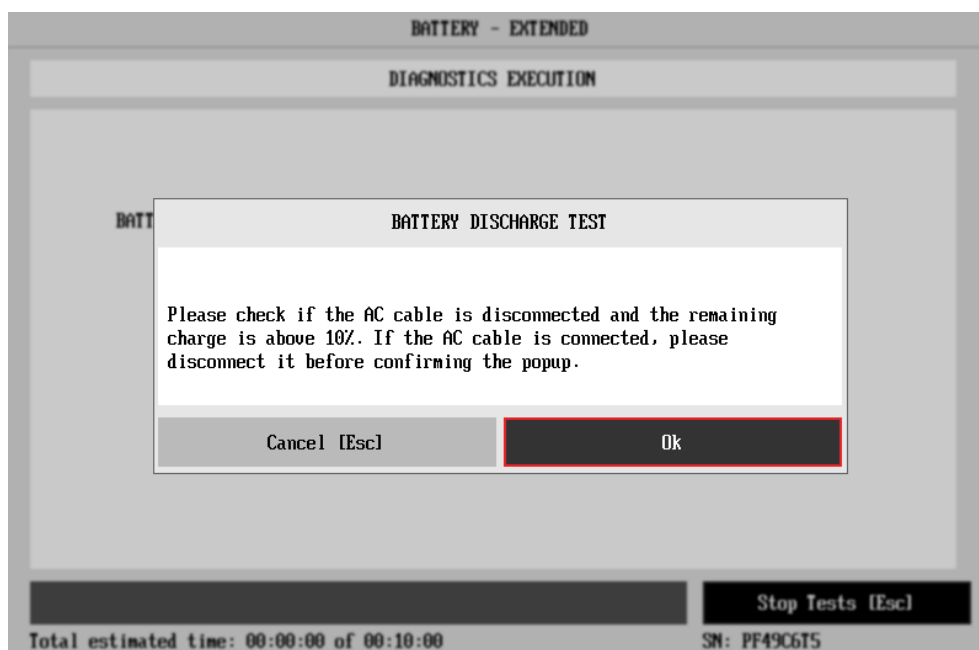


Figure 19: Attended Execution Example 01

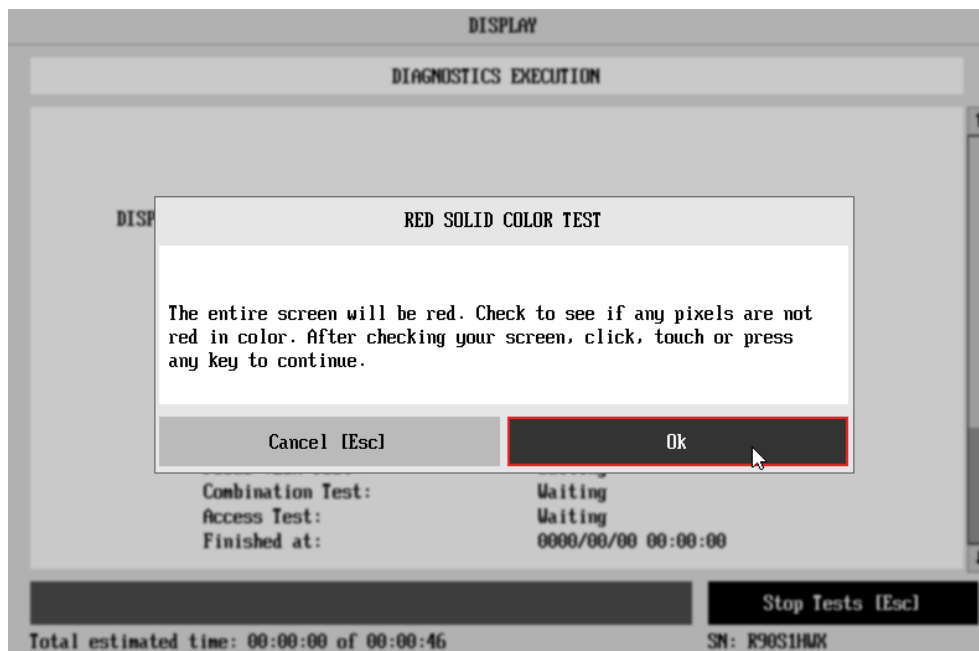


Figure 20: Attended Execution Example 02

6 Run All Diagnostics

In addition to the common execution flow described above, there is another way for the user to perform diagnostics in the Lenovo UEFI Diagnostics application, which is through the Run All section. The Run All option can be accessed from the Home screen by clicking the Run All button located below the Diagnostics Section



Figure 21: Run All Button in Home Screen

● Run All Button

6.1 Run All Options

When the user clicks the Run All button, the application redirects them to the Run All Diagnostics Type Screen. The Run All options combine diagnostics from all available modules in the application and execute all of them in a single run. There are different combinations for these diagnostics.

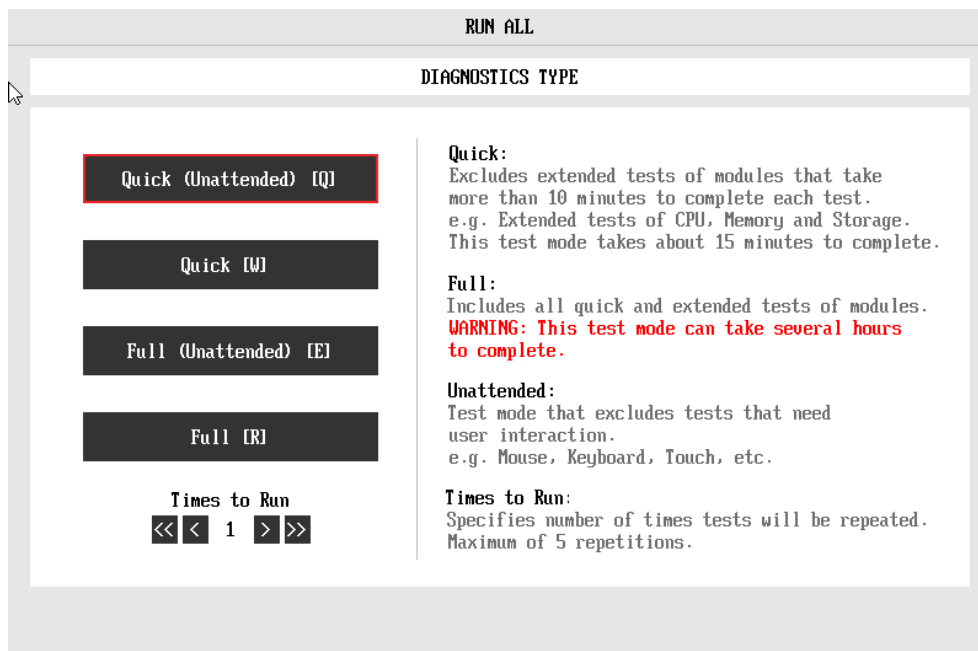


Figure 22: Run All Options

The **“Quick (Unattended)”** and **“Quick”** options select all available tests considered Quick, which, as mentioned in the previous chapter, are those that take less than 10 minutes to complete. The **“Full (Unattended)”** and **“Full”** options select all available diagnostics, including Quick and Extended executions. The options marked as “Unattended” represent diagnostics that do not require user interaction, while the other options require user interaction during some of the diagnostics.

6.2 Run All Execution Flow

After choosing one of the options, the application will redirect the user to the Run All Execution Screen. This screen is the same from the previously explained Execution Screen, as shown in the image below:

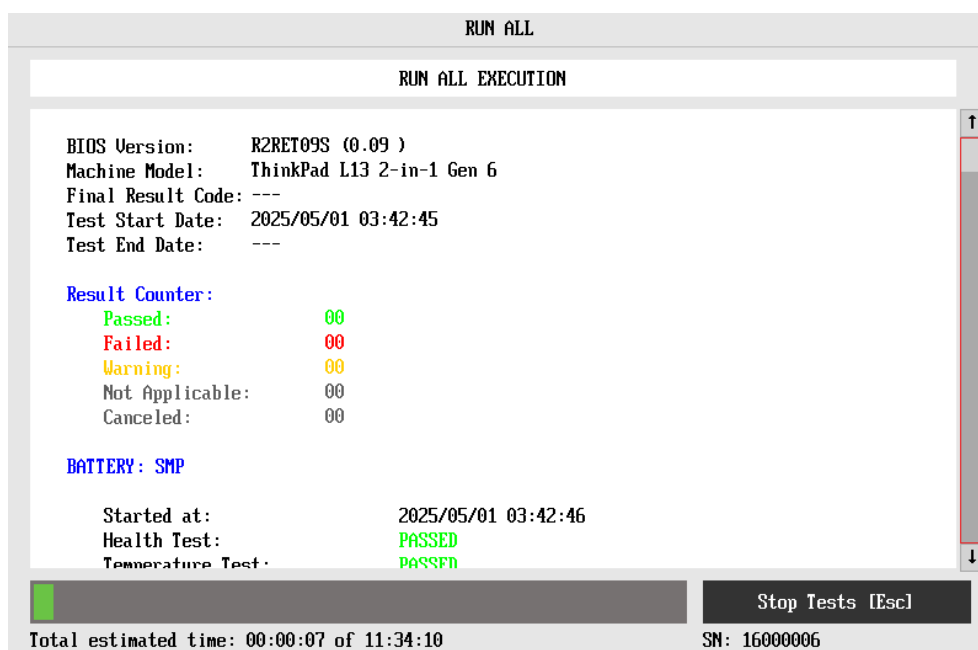


Figure 23: Run All Execution Screen

Once the execution is complete, the application shows the Run All Result Screen. The layout is similar to the Run All Execution Screen, but with the addition of a button to view the execution log, a QR Code containing some additional machine information and the Final Result Code. Also, on the left side of the QR Code it's possible to see some machine information and the Status result counter.

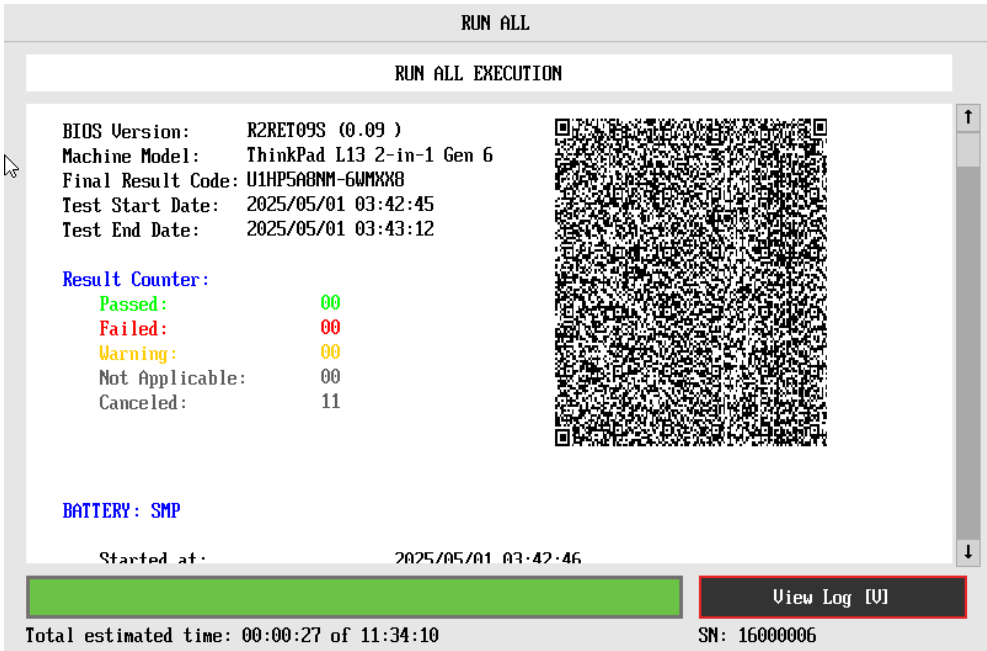


Figure 24: Run All Result

When the user clicks the View Log button, they are redirected to the Run All Diagnostics Result Log screen, where a Save Log button can be found. The structure of the Run All log and the behavior of the save button follow the same process described in the Diagnostic Result and Log section of the Module Diagnostic chapter.

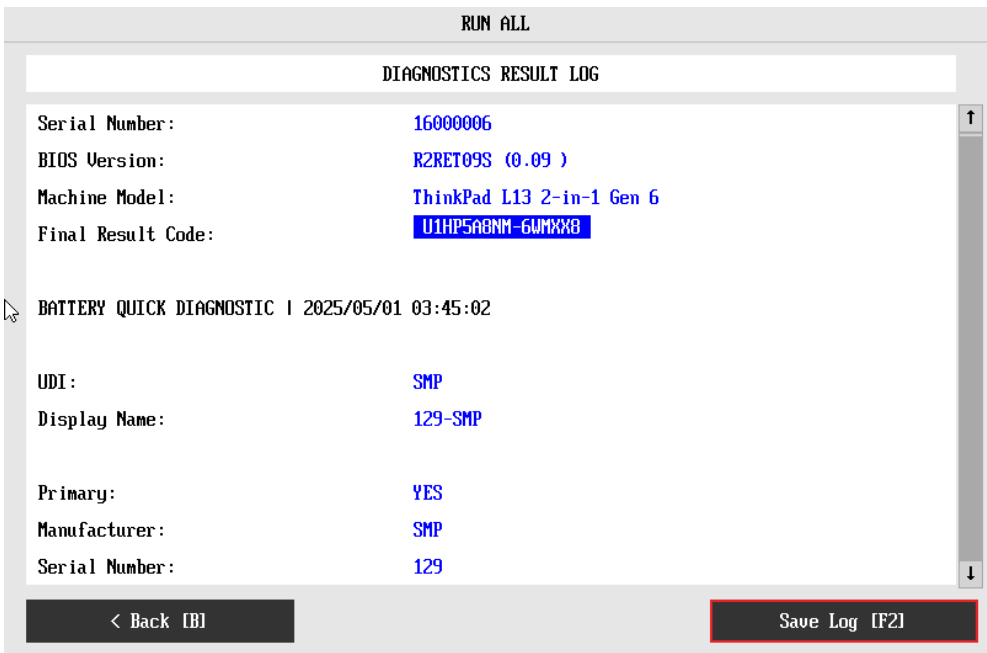


Figure 25: Run All Log

7 Modules and Diagnostics

The Lenovo UEFI Diagnostics currently supports a list of seventeen different modules:

- Audio
- Battery
- CPU
- Display
- Fan
- Keyboard
- Memory
- Motherboard
- Mouse
- Optical
- RAID
- Sensor
- Storage
- Touch
- Wired Ethernet

In this chapter, we will cover each supported module and its diagnostics, along with explanations for the attended diagnostics, which focus on how the user should interact with the application during the diagnostics execution.

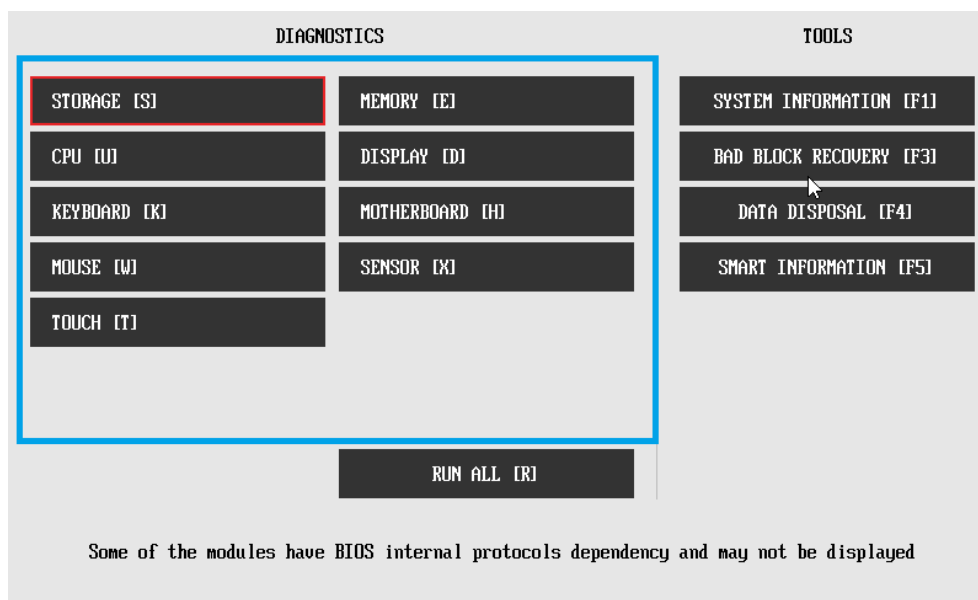


Figure 26: Lenovo Diagnostics Section

● Diagnostics Section

7.1 Audio



Audio module is only available for machines with ALC3287 audio chipset

Quick Diagnostics:

- Internal Speaker Test: This module tests only the internal speaker that is integrated into the systems motherboard.

7.2 Battery

Quick Diagnostics:

- Health Test: This test measures the battery health according Power Manager battery condition feature.
- Temperature Test: This test measures battery temperature and obtains battery status through AlarmWarnings about temperature.

Extended Diagnostics:

- Charge Test: This test will validate if the battery is charging properly.
- Discharge Test: This test will validate if the battery is discharging properly.

7.2.1 Battery Diagnostic Interactions

For the Charge diagnostic, the charger must be connected. If it's not connected, a popup will appear to remind the user to connect the charger. This popup closes automatically once the charger is connected.

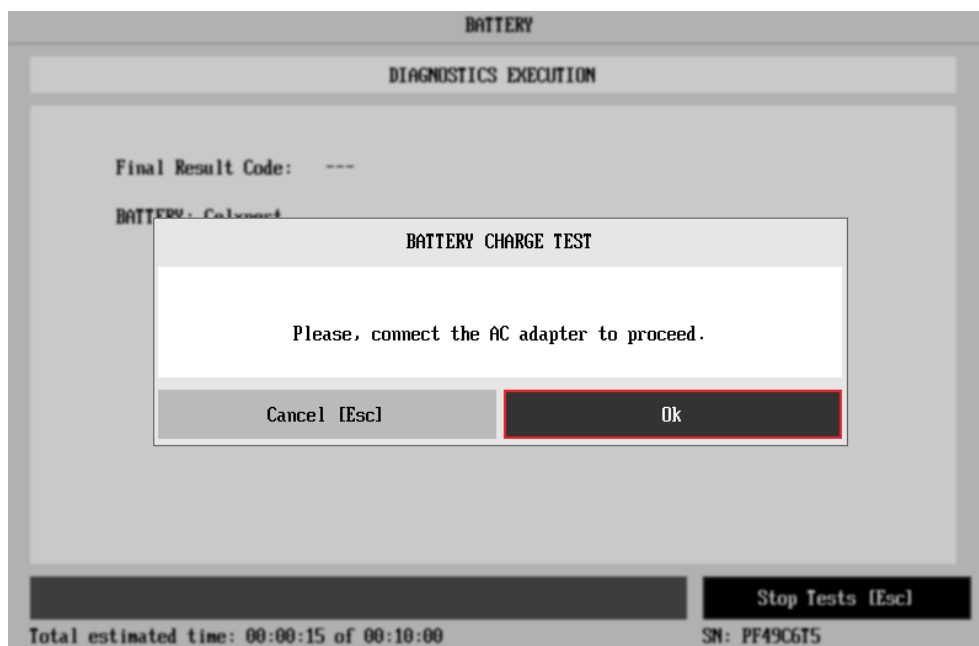


Figure 27: Connect the charge AC popup

The threshold for the Charge diagnostic is 95%. The battery should have 95% or less of charge. If the charge is higher, the diagnostic will result in "Not Applicable" because the threshold was not met.

For the Discharge diagnostic, the threshold is 10%. Since the test will discharge the battery, it's important to start with at least 10% charge. If the battery has less than 10% charge, the diagnostic will be considered "Not Applicable" and notify the user that the pre-conditions were not met.

Once all pre-conditions for the Charge and Discharge diagnostics are met, the test can start. For both diagnostics, the application will check for a 1% variation (either charging 1% or discharging 1%). If this variation is detected, the test is considered complete.

7.3 CPU

Quick Diagnostics:

- Register Test: The test makes various arithmetic operations in all available registers in order to verify if the values read in these registers are the same that were previously written.
- BT Instruction Test: The test checks if the BT (Bit Test) instruction is working properly.
- X87 Floating Point Test: The x87 instruction set includes instructions for basic floating point operations (such as addition, subtraction and comparison) and also for complex numerical operations (such as trigonometric functions).
- MMX Test: MMX technology is designed to accelerate the performance of advanced media and communications applications.
- 3DNow! Test (AMD Only): Tests the 3DNow! instructions on AMD processors.
- SSE Test: SSE Technology enhances the performance of processors for advanced 2-D and 3-D graphics, motion video, image processing, speech recognition, audio synthesis, telephony, and video.
- AES Test: The purpose of the instruction set is to improve the speed of applications performing encryption and decryption using the Advanced Encryption Standard.
- FMA Test: The FMA instruction set is an extension of SSE instructions to perform "fused multiply-add" operations.
- AVX2 Test: AVX2 (Advanced Vector Extensions 2) is 256-bit instruction set that expands the AVX (Intel Advanced Vector Extensions) Instruction Set, and its purpose is to extend the vector processing capabilities across floating-point and integer data domains.
- Cache Test: Cache test is to actually perform some indirect test via code implemented in C language, which will force the cache hierarchy to work.
- AVX512 Test: AVX-512 is a SIMD (Single Instruction, Multiple Data) instruction set that can process up to 512 bit of data in a single fetch.
- CLMUL Test: The CLMUL is an extension to the x86 instruction set that provides a hardware instruction to perform a carry-less multiplication.
- SHA Test: The SHA Extensions are a family of seven Streaming SIMD Extensions (SSE) based instructions that are used together to accelerate the performance of processing SHA-1 and SHA-256 on x86 architecture processors.
- TSX Test: The TSX is an extension of the x86 instruction set architecture that adds hardware transactional memory support, speeding up execution of multi-threaded software through lock elision

Extended Diagnostics:

- Stress Test: In Stress Test, all Features and Instructions quick tests, which are supported by the processor, are executed cyclically in each core at the same time.

7.4 Display

Quick Diagnostics:

- Red Solid Color Test: Verifies the display's ability to show a solid red color.
- Blue Solid Color Test: Verifies the display's ability to show a solid blue color.
- Green Solid Color Test: Verifies the display's ability to show a solid green color.
- Black Solid Color Test: Checks for dead pixels on a black screen.
- White Solid Color Test: Verifies the display's ability to show a solid white color.

- Luminance VESA Test: In this test, black rectangles will be painted on a white background and a check will be made if the edges of the rectangles are sharp and not blurred.
- Geometry VESA Test: In this test lines, rectangles and circles will be painted on the canvas and checked if the geometric figures are displayed correctly.
- Focus VESA Test: In this test lines, rectangles and circles will be painted on the canvas and checked if the geometric figures are displayed correctly.
- Combination Test: In this test, three features will be displayed on the screen to determine if the monitor is correctly aligned and set to the correct resolution.
- Access Test: This test consists on validating display data integrity.

7.4.1 Display Diagnostic Interactions

With the exception of the Access Test, all other diagnostics in the display module require user interaction. This means the user must validate the behavior of the display and then report the results to the application. Incorrect responses from the user could mislead the application into reporting the wrong status, so it is crucial to answer accurately based on the observed behavior.

For each test, the application will display an informative popup explaining what the diagnostic will do with the system display. This may include drawing solid colors or various patterns of circles and rectangles.

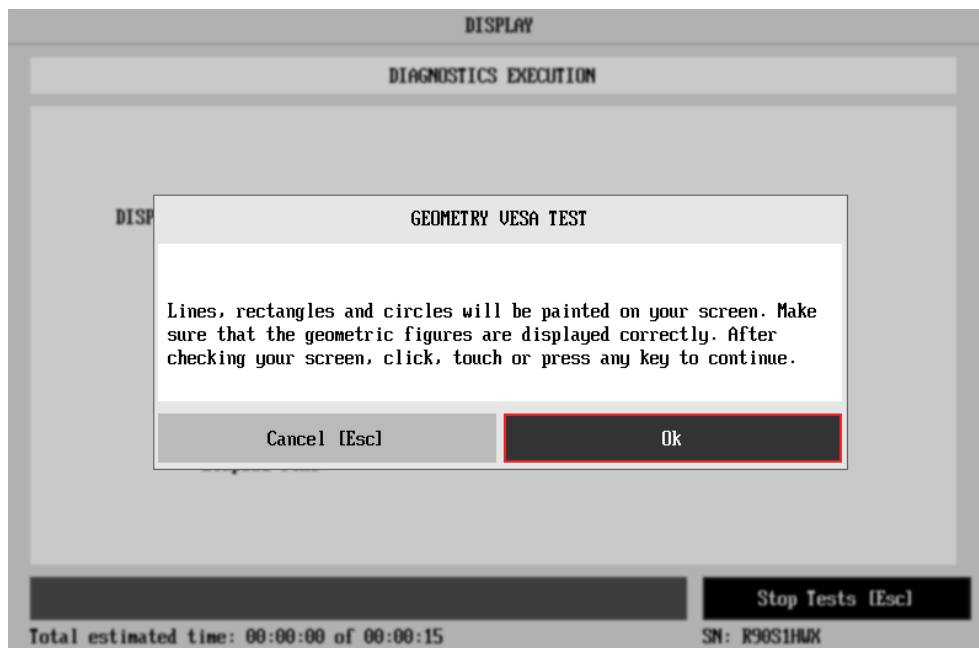


Figure 28: Display Info Popup

After the explanation, the application will display what was described on the screen. At this point, the user can interact by pressing any key, and the application will prompt another popup asking whether the screen was displayed correctly.

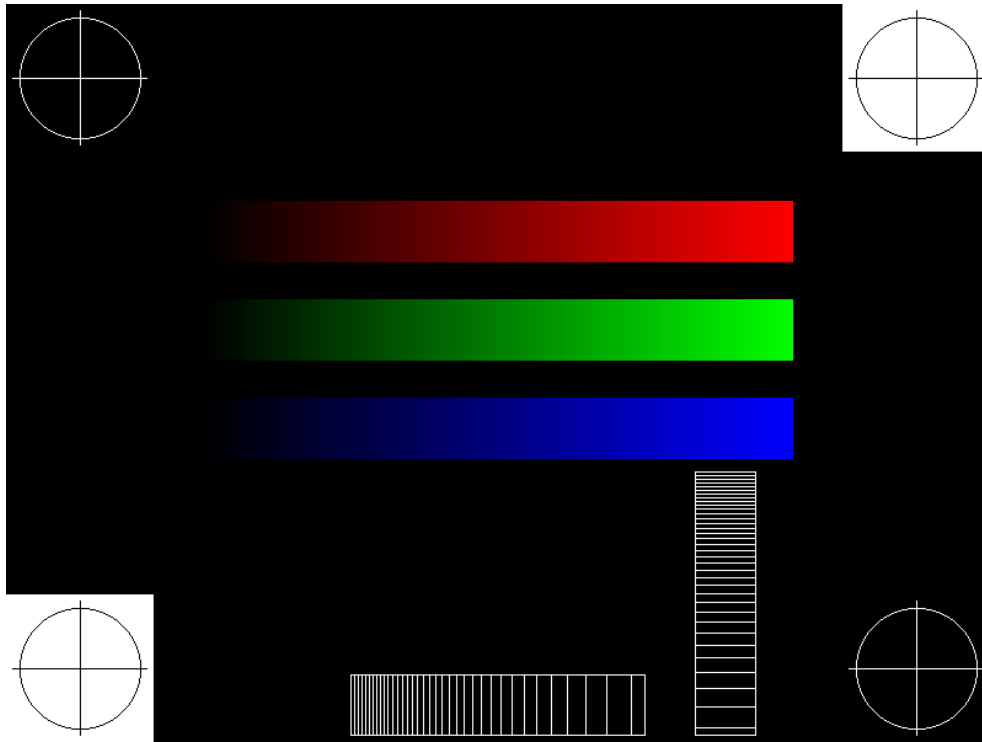


Figure 29: Example of Combination Test screen

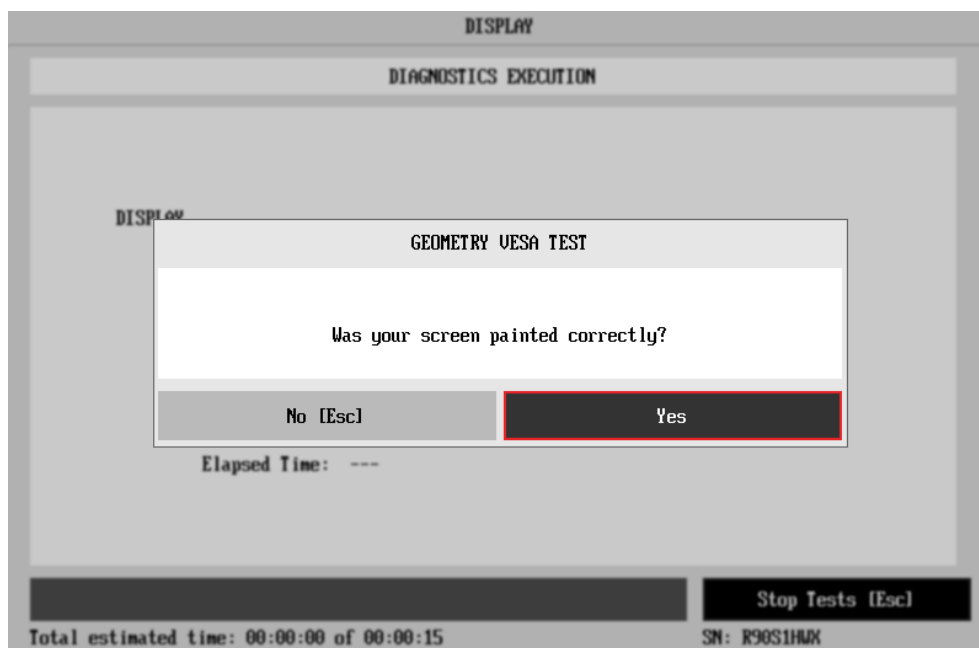


Figure 30: Display Confirm Popup

7.5 FAN



Fan module is only supported for ThinkPad machines

Quick Diagnostics:

- Control Test: The test will check if the fan controller is able to work on higher speeds according to predefined levels in the firmware.

7.6 Keyboard



Keyboard module is only supported for ThinkPad machines

Quick Diagnostics:

- PS/2 Test: This test performs a reset operation on the hardware executing the Simple Text Protocol reset command for PS/2 devices.
- USB Test: Checks if all necessary UEFI protocols and structures are correctly allocated and working with the specified handle of the actual physical keyboard device.
- Key Test: Is an attended test where the user checks whether the keys are properly working for PS/2 keyboards.
- USB Key Test: Is an attended test where the user checks whether the keys are properly working for USB keyboards.

7.6.1 Keyboard Diagnostic Interactions

For the keyboard interaction in Key Test and USB Key Test a customized execution screen will appear for the user so he can validate the keys of his device. The idea is that for each pressed key the application will show in a text box if the key was properly recognized. At the end of test when user quit the application will ask if the keys were correctly identified. Wrong user answers will lead to wrong test results.

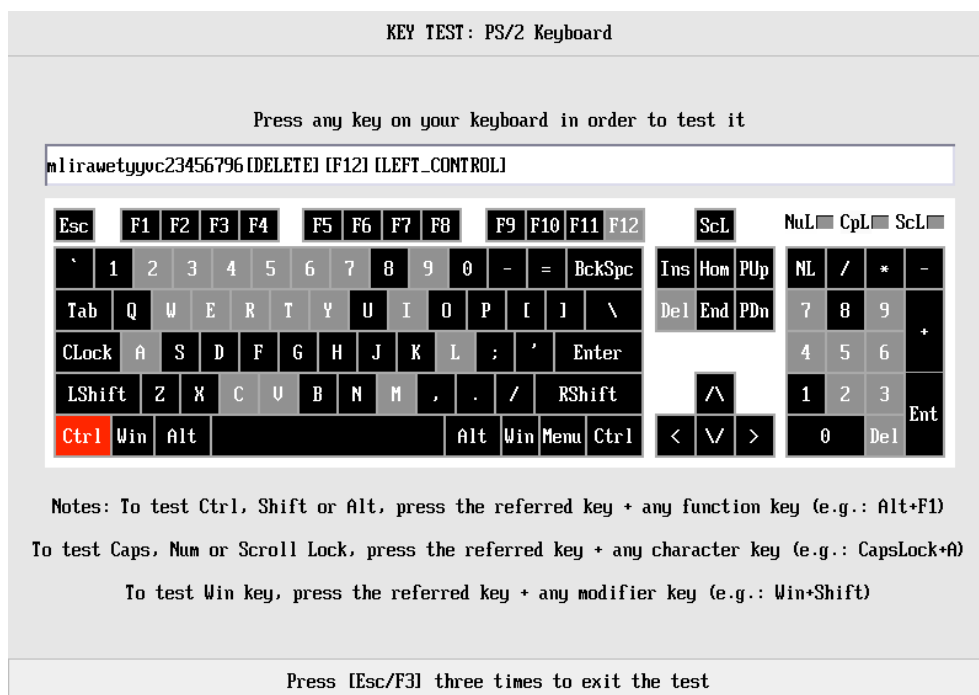


Figure 31: Keyboard Custom Execution Screen

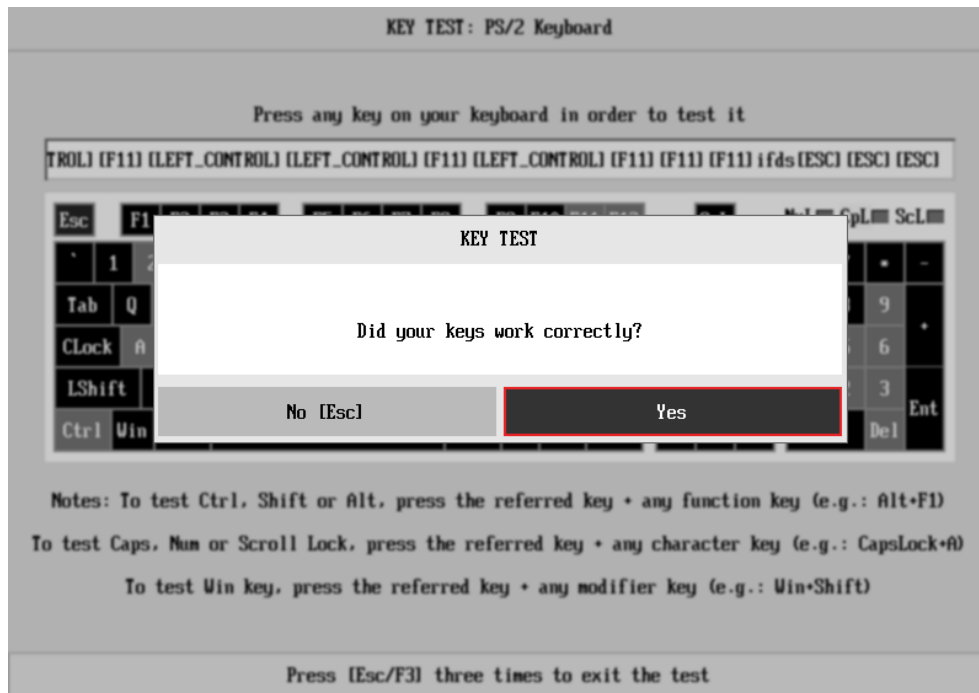


Figure 32: Keyboard Question Popup

7.7 Memory

Quick Diagnostics:

- Quick Random Pattern Test: The test consists in filling the memory from every block with a random generated pattern and then checking if such pattern was correctly written.

Extended Diagnostics:

- Advanced Integrity Test: The Advanced Integrity Test is based in March C Minus algorithm, up to this date the LDiags UEFI uses three variations of March C Minus: two variations of Modified March C- and one of Enhanced March C-.
- Address Test: This test consists in writing to each memory address its own address, for each memory block. After that, the algorithm reads the memory previously written and checks if they still store their own address.
- Bit High Test: This test consists in filling the memory buffer from every block with a pattern where all bits are 1 and then checking it.
- Bit Low Test: This test consists in filling the memory buffer from every block with a pattern where all bits are 0 and then checking it.
- Walking Ones Right Test: The Walking Ones Right Test consists of writing a pattern where only the leftmost bit is set (e.g. 10000000), then shift this pattern to the right (e.g. 01000000) until the end of the size of a byte, writing it again at the same memory address each time such pattern is shifted.
- Walking Ones Left Test: The Walking Ones Left Test consists on writing a pattern where only the rightmost bit is set (e.g. 00000001), then shift this pattern to the left (e.g. 00000010) until the end of the size of a byte, writing it again at the same memory address each time such pattern is shifted.
- Modulo-20 Test: The test consists in writing into an interval of 20 memory locations for each block with a pattern and filling all other locations with its complement 6 times.
- Moving Inversions - 8-bit Test: The test consists in filling the memory with the 8 bit wide pattern: 10000000 and then checking if such pattern was correctly written.
- Moving Inversions - 32-bit Test: This test fills all the accessible memory with a shifting pattern, that is, a value which is binary left shifted as it is written out through the accessible memory of every memory block.

- Random Pattern Test: The test consists in filling the memory from every block with a random generated pattern and then checking if such pattern was correctly written.
- Random Number Sequence Test: The test consists in filling the memory with one different random generated pattern for each memory address and then checking if the pattern was correctly written.
- Block Move Test: The algorithm consists of moving memory data around within memory blocks.
- Bit Fade Test: The Bit Fade test consists of filling all the accessible memory with 0s, waiting for a time period and checking if these values haven't changed.

7.8 Motherboard

Quick Diagnostics:

- Chipset Test: The purpose of the test is to detect problems with the motherboard chipset checking the status of each detected HCI controller.
- PCI/PCIe Test: Validates the integrity of different PCI and PCI-e capabilities.
- RTC Test: This test checks the accuracy of the RTC when date and time rollovers occur besides verify the accuracy of the RTC on the motherboard and compares it to the CPU clock to determine if the motherboard and CPU clock are out of sync.
- USB Test: Assesses the functionality of USB ports.
- USB Replaceable Type-C Test: Detects issues with replaceable USB-C ports by checking the status of each detected USB-C port. If a failure is detected, only the connector or small board needs to be replaced, not the entire motherboard.
- External Ports Test: Validates the connectivity of the external ports (only USB supported for now).

7.8.1 Motherboard Diagnostic Interactions

For the External Ports Test, there is a custom execution screen that counts the number of external port connections during the test run. When the user connects a device to the external ports (USB-A or USB-C), the counter increments, indicating to the user that the port has been validated.



Figure 33: External Ports Execution Screen

7.9 Mouse



Mouse module is only supported for ThinkPad machines

Quick Diagnostics:

- Reset Test: This test performs a "reset" operation on the hardware.
- Mouse Test: Attended test that lets the user test the click of Left and Right buttons of the mouse and the mouse movement detection, if available.
- USB External Mouse Test: Same as Mouse Test but for the USB external mouse.
- Precision Test: An attended test that validates the mouse's ability to hold click and drag.

7.9.1 Mouse Diagnostic Interactions

For the Mouse Test and USB External Mouse Test a customized screen will be displayed to the user so he can validate the mouse behaviors of movement and button clicks. The customized screen will indicate the movements and buttons user interact with. After the user quits the application will ask if everything work as expected. Wrong answers lead to wrong results.

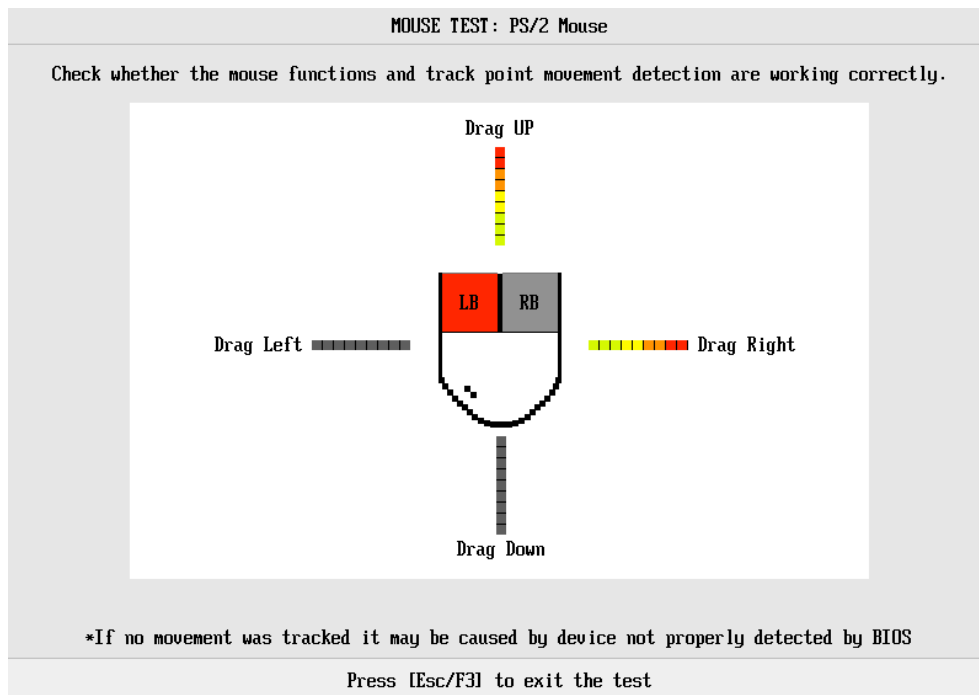


Figure 34: Custom Mouse Execution Screen

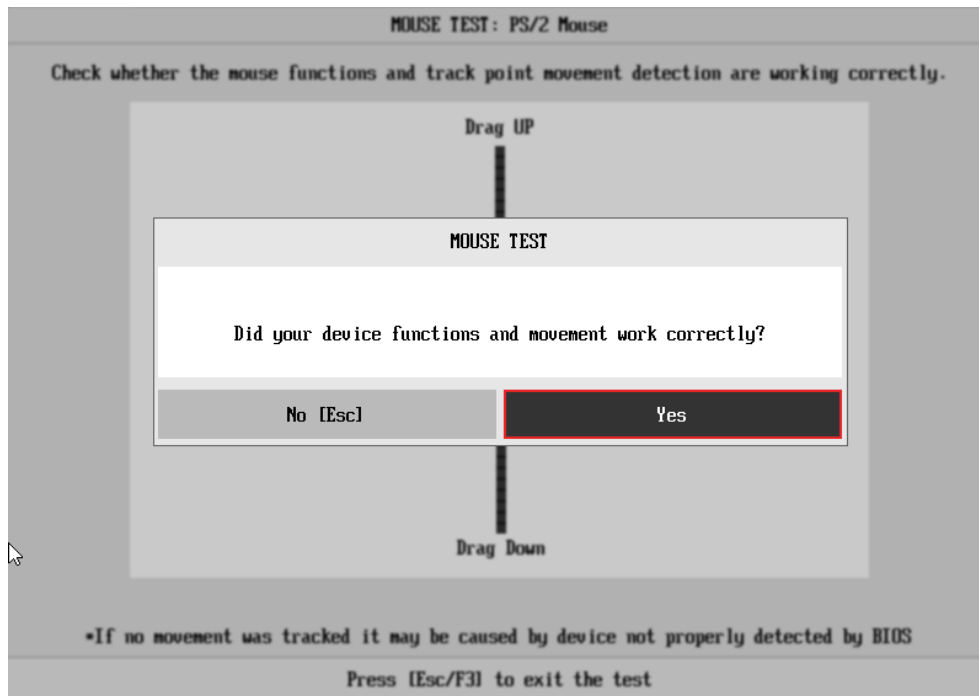


Figure 35: Mouse Question Popup

The Precision Test also utilizes a customized screen to perform the diagnostic. The intent of this test is to validate the mouse's functionality when holding the click and dragging the cursor. To successfully complete the test, the user must drag a scrollbar down. If the user is unable to drag the scrollbar down, the diagnostic will be considered a failure.

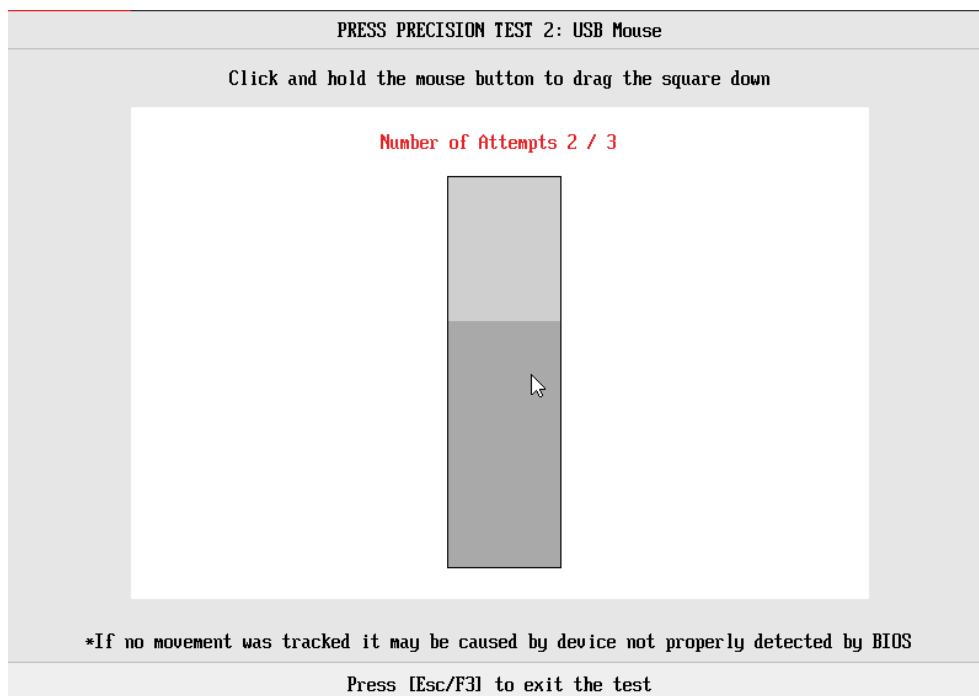


Figure 36: Mouse Precision Test Screen

7.10 Optical

Quick Diagnostics:

- Funnel Seek Test: The idea of this test is to check if the optical device equipment has some physical problem to move its optical reader.
- Linear Seek Test: The linear seek test is intended to detect if the optical head is working as expected.
- Random Seek Test: The Random seek test was created if the optical head is able to move to all directions, without follow a pattern.
- Read and Compare Test: The intent of this test is to check if the optical drive is able to read information from a media without changing its content.
- Write Test: The write test was created to check if the optical drive is able to write some data to a media.

7.11 Raid



It's possible to run tests for physical and virtual RAID controllers. The virtual volumes supported from Intel technologies are VROC SATA, and RST SATA or NVMe.

Quick Diagnostics:

- Status Test: The RAID Controller Status is intended to check any Device error detected by the PCIe system capabilities.
- Slot Test: The RAID Controller Slot Test is intended to check any Slot error detected by the PCIe system capabilities.
- Link Test: The RAID Controller Link Test is intended to check any Link error detected by the PCIe system capabilities.
- Advanced Error Test: The RAID Controller Advanced Error Test is intended to check any Link error detected by the PCIe system capabilities.

Extended Diagnostics:

- Logical Device Read Test: This test consists of validating the storage when the controller is set to RAID, it performs a read in all the blocks of the created volume using the Block I/O protocol.

7.12 Sensor



Sensor module is only supported for ThinkPad machines

Quick Diagnostics:

- Lid Closure Test: The lid closure test uses the Embedded Controller Function to check the Sensor Status Register of the lid device and tries to detect any change when asked to close the lid.
- Accelerometer Self Test: The Accelerometer Self-Test uses the Embedded Controller functions to check the sensor readings at different times to compare the readings.

7.12.1 Sensor Diagnostic Interactions

The Sensor Lid Closure Test is an attended test that verifies if the Lid open and close functions are being well detected and by the embedded controller. In order to validate the lid closing and opening functions the user must perform the operation to close and open the machine lid, without this interaction the test will give wrong results.

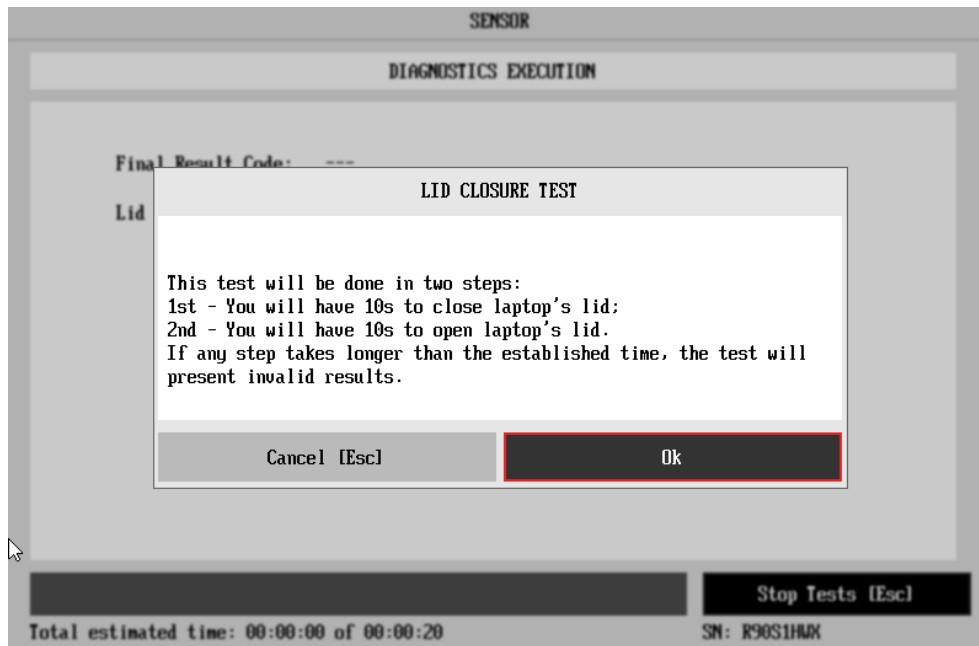


Figure 37: Sensor Popup

7.13 Storage



The storage devices connected as RAID will be disabled by UEFI diagnostics application, therefore they can't be tested on the Storage.

Quick Diagnostics:

SATA:

- SMART Status Test: The application will check de SMART registers present on the storage device.
- SMART Short Self-Test: The application sends a command to the storage device, to start a Self-Test routine in background mode
- Drive Self-Test: The Drive Self-Test follows the same flow as the SMART Self-Test.
- Random Seek Test: Checks sectors at several randomly chosen addresses.
- Funnel Seek Test: The application will try to find defective sectors of the first 100 sectors.
- Target Read Test: The application sends a command to the storage device, to read the device log.

SSD:

- SMART Status Test: The application will check de SMART registers present on the storage device.
- SMART Short Self-Test: The application sends a command to the storage device, to start a Self-Test routine in background mode
- Target Read Test: The application sends a command to the storage device, to read the device log.
- SMART Wearout Test: Checks the wearout level of the attached SSD device by reading SMART attributes and tells you whether the device is in good condition or has reached its wearout limit.

eMMC:

- Device Read Test: Verifies a storage device in order to detect possible disturbs regarding the reading process

NVMe:

- Device Read Test: Verifies a storage device in order to detect possible disturbs regarding the reading process
- NVMe Controller Status Test: Checks the status of the controller by reading the Status register
- NVMe SMART Temperature Test: Checks if a given NVMe device has passed the critical temperature threshold.
- NVMe SMART Spare Space Test: Check if the spare space of a given NVMe device is near to end.
- NVMe SMART Reliability Test: Checks if a given NVMe device is still reliable, based on SMART metrics
- NVMe Short Self-Test: Starts a Self-Test routine in background mode.

Optane:

- Device Read Test: Verifies a storage device in order to detect possible disturbs regarding the reading process
- Optane Health Test: This "Health Test" verifies if the Optane device is healthy.

UFS:

- Device Read Test: Verifies a storage device in order to detect possible disturbs regarding the reading process

Extended Diagnostics:

- Bad Block Test (For SATA, SSD, and NVMe): Identifies defective sectors on the drive.
- Linear Read Test (For SATA and SSD): Scans the whole drive using a pre-defined block size that is used on each step of the test.
- NVMe Extended Self-Test (For NVMe): Starts a Self-Test routine in background mode.
- UFS Read Test (For UFS): The purpose of this test is to verify the integrity of the UFS device, access its read capabilities, and identify any potential issues or errors.

7.14 Touch

Quick Diagnostics:

- Reset Test: This test performs a "reset" operation on the hardware.
- Grid Test: This test lets the user test touch detection on all screen surfaces.

7.14.1 Touch Diagnostic Interactions

The Touch Grid Test allows the user to paint a black screen in order to validate if the screen can be touched in all pixels. The main goal is to validate if there are points in screen that for some reason can't identify touch interaction. If user quits the test the application will ask if it worked, wrong answers lead to wrong results.

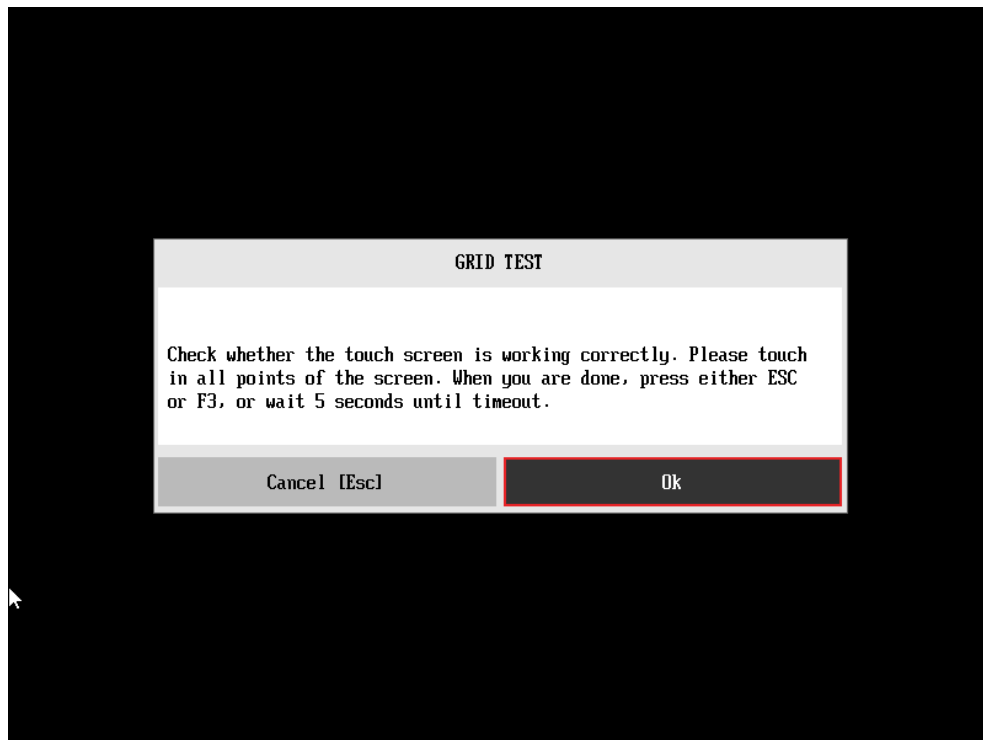


Figure 38: Touch Explaining Popup



Figure 39: Touch Paint Screen Grid Test



Figure 40: Touch Question Popup

7.15 Wired Ethernet

Quick Diagnostics:

- Internet Connection Test: The purpose of the Internet Connection Test for Wired Ethernet adapters is to check the internet connection and if the hardware device is working properly by performing a "ping" operation in a list of DNS addresses.

8 Lenovo UEFI Tools

In addition to the diagnostics available within the modules and the "Run All" option, the Lenovo UEFI Application provides several tools for performing specific operations on the machine. These tools can be accessed from the application Home Screen. To execute a tool, the user should select the desired option and follow the respective workflow.

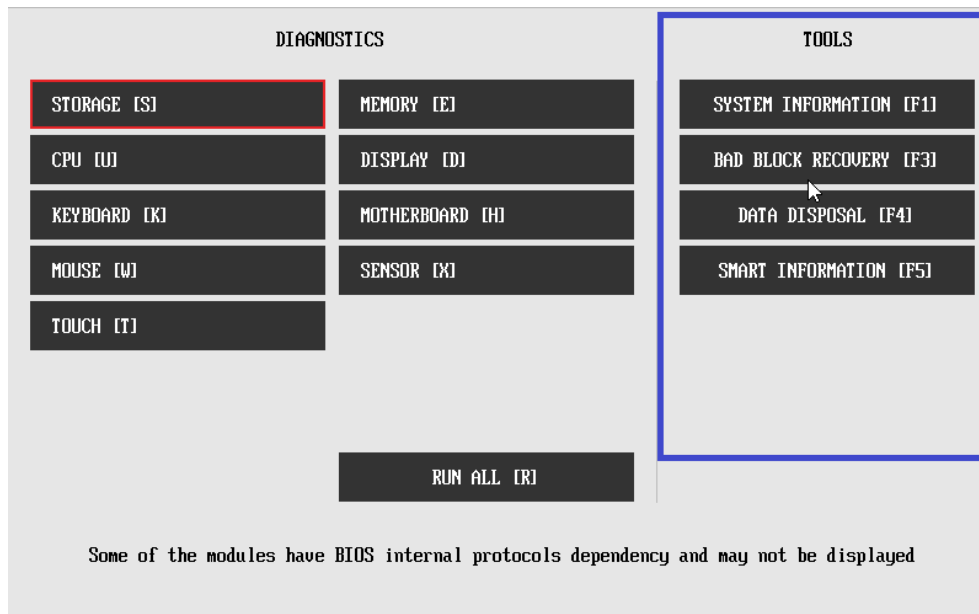


Figure 41: Tools

● Tools Section

8.1 Available Tools

Not all tools are available on every machine. Similar to the modules, some tools depend on specific BIOS protocols. If a machine does not meet the required dependencies, the tool will not be supported or displayed.

- System Information
- Bad Block Recovery
- Hardware Diagnostic Events
- Data Disposal
- SMART Information
- Fan Speed

8.1.1 System Information

The System Information tool provides users with detailed information about all supported modules. Each module will appear on the screen with specific details.

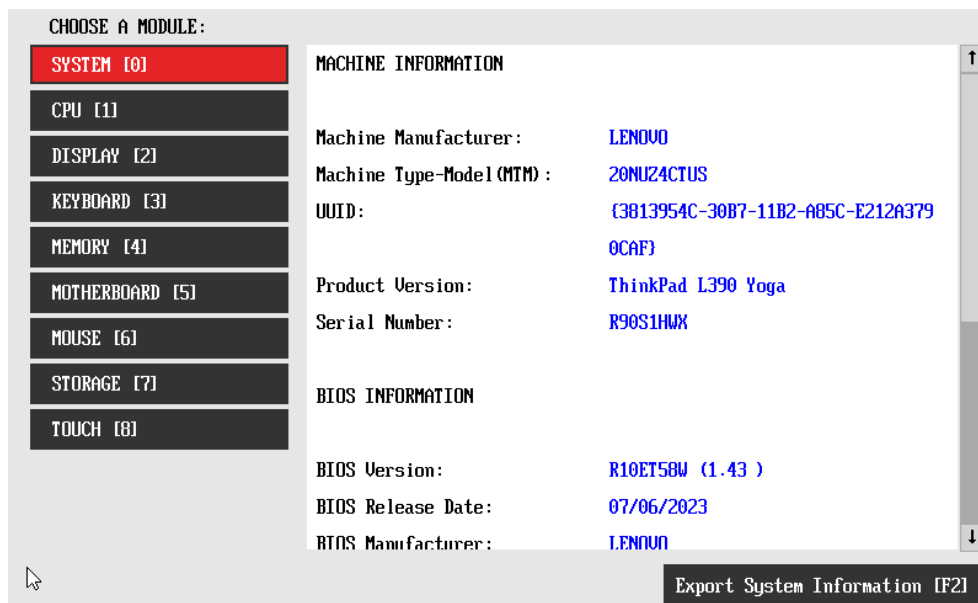


Figure 42: System Information

In addition to displaying information, the System Information tool allows users to export the displayed data as a text file. To do this, the user must select the "Export System Information" button or press the shortcut F2. A popup will then alert the user about the sensitive nature of the information being exported. If the user consents, the file will be generated.

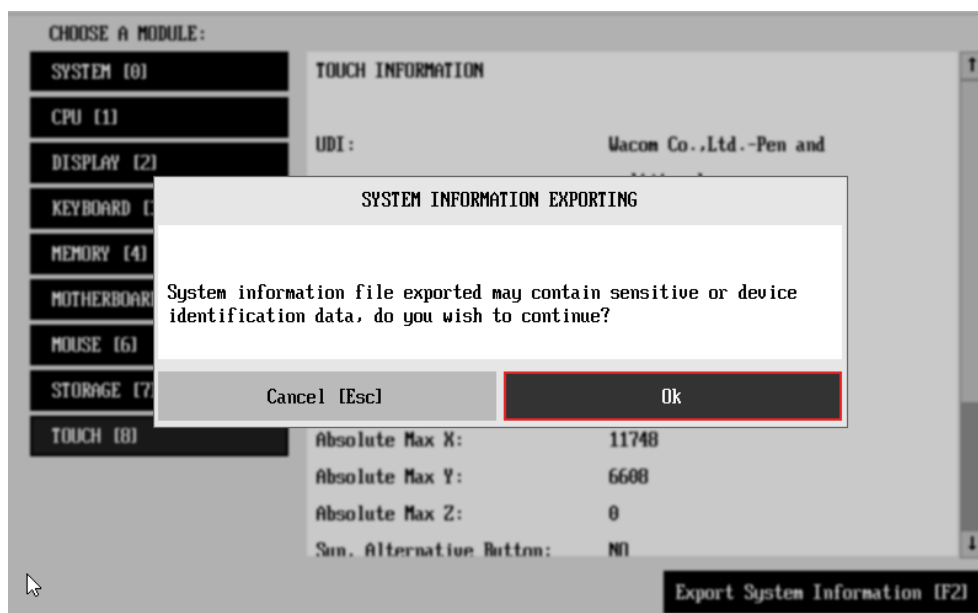


Figure 43: Sensitive Popup

8.1.2 Bad Block Recovery

The Lenovo UEFI Bad Block tool is designed to read a storage device while searching for potential bad blocks. A "block" refers to the smallest addressable region on a storage device. This tool not only identifies bad block sectors but also attempts to repair them, making them valid addresses again.

The workflow for this tool is similar to the diagnostics execution flow. It begins with the user selecting the device on which to run the Bad Block Recovery tool.

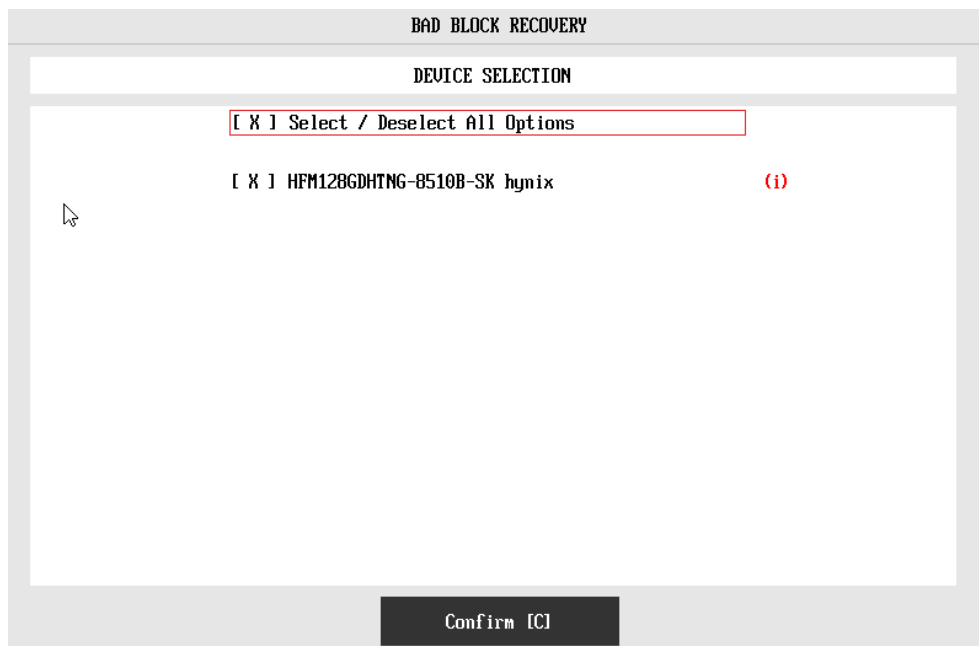


Figure 44: Bad Block Recovery Tool Device Selection

After selecting the device, the tool will redirect the user to choose an algorithm for the Bad Block Recovery. In this screen, users can access information about the algorithm used.

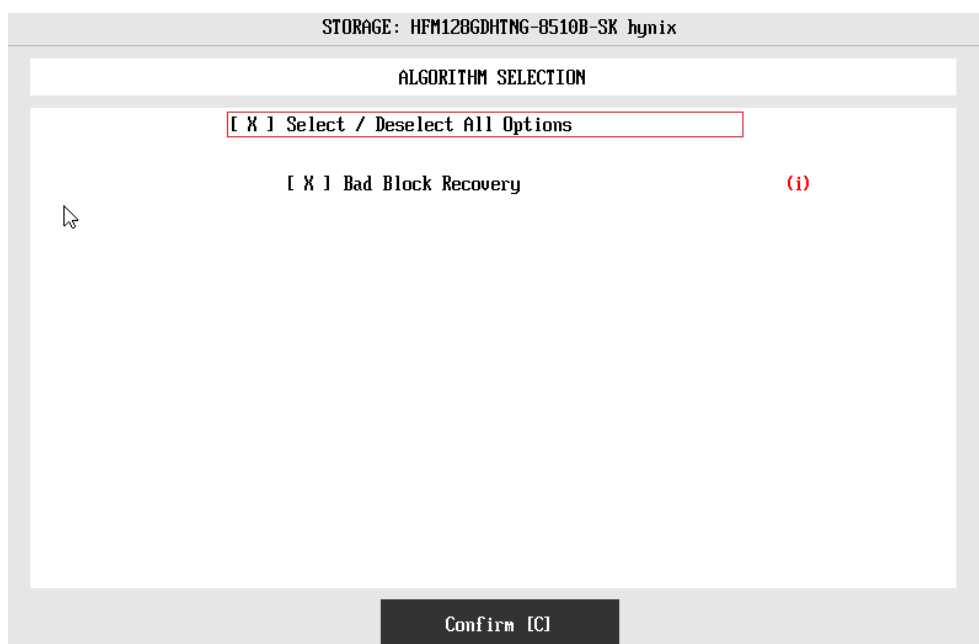


Figure 45: Bad Block Recovery Tool Algorithm Selection

Once the algorithm is selected, the tool will begin searching for bad blocks and attempting repairs. Before starting, a warning popup will remind the user to back up their data. If the user consents, the process will start.

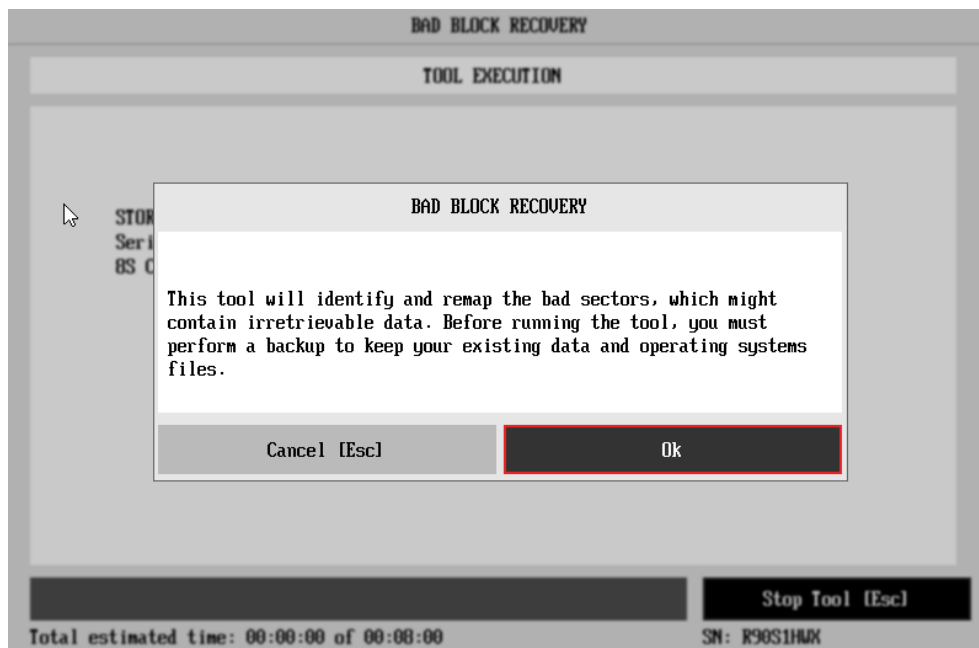


Figure 46: Bad Block Recovery Tool Warning

The execution flow and view log option are identical to those described in the "Executing Diagnostics" chapter. The difference is in the Bad Block Recovery Result Screen, which does not contain the QR Code or Final Result Code.

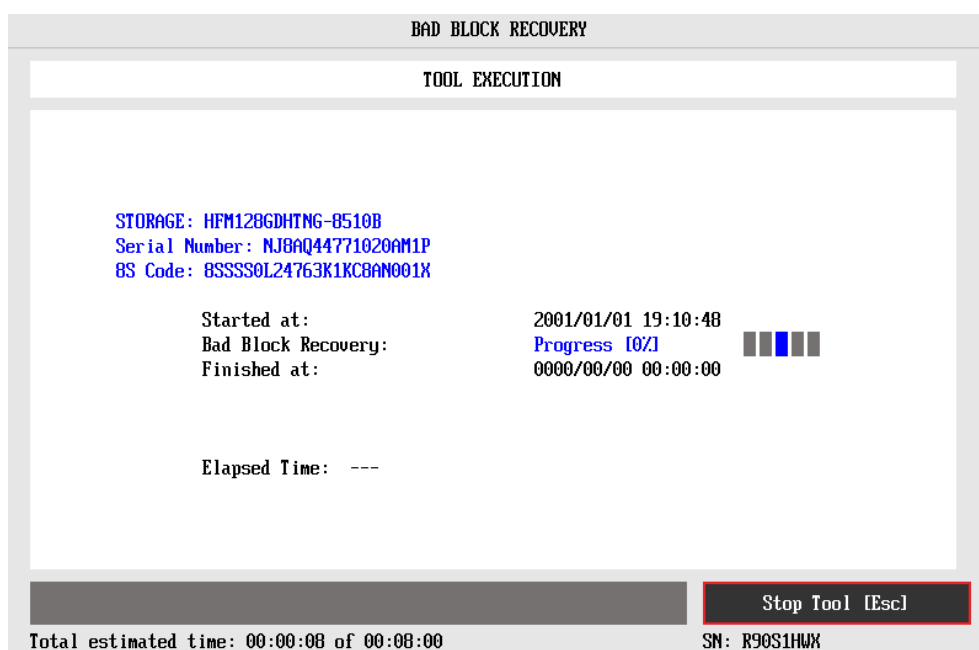


Figure 47: Bad Block Recovery Execution

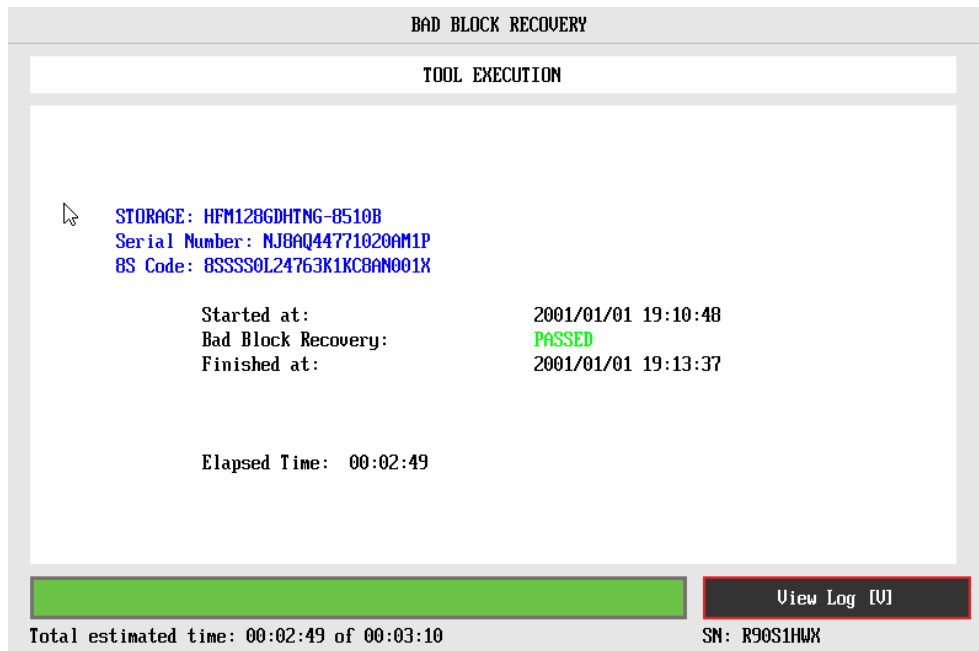


Figure 48: Bad Block Recovery Result

8.1.3 Hardware Diagnostic Events

Lenovo ThinkStation features real-time hardware diagnostics, recording and logging errors on the EEPROM of Super I/O. This includes power-on and runtime log errors for system events. The Hardware Diagnostic Events tool displays all logged events of the machine.

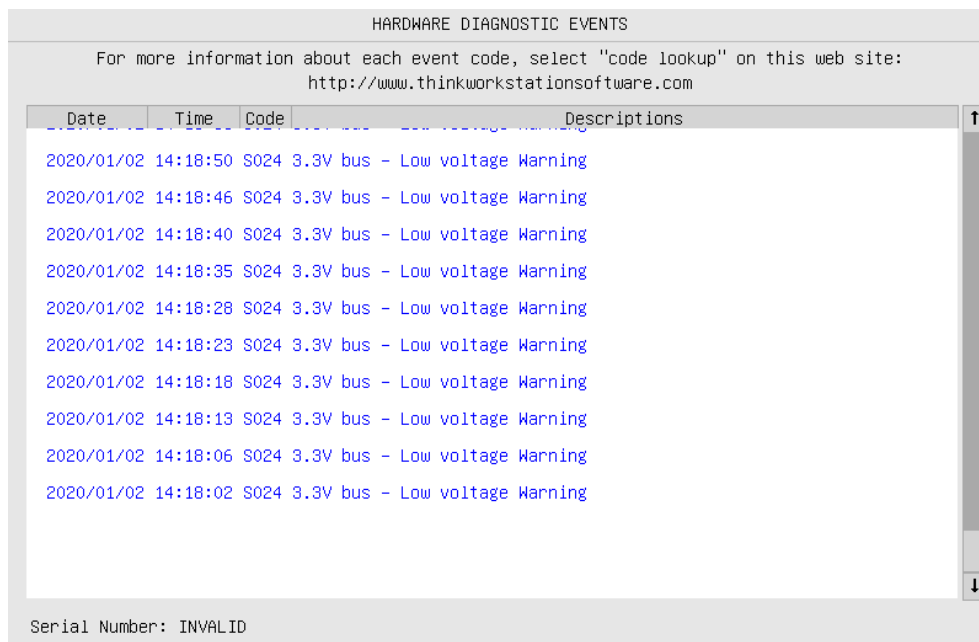


Figure 49: Hardware Diagnostic Events

8.1.4 Data Disposal

The Data Disposal tool is responsible for erasing all data in storage partitions. It offers two algorithms: Data Disposal Quick and Data Disposal Full. The Full option erases all data from the storage device, while the Quick option writes zeros to the MBR, GPT, and GPT Backup table across the entire disk.

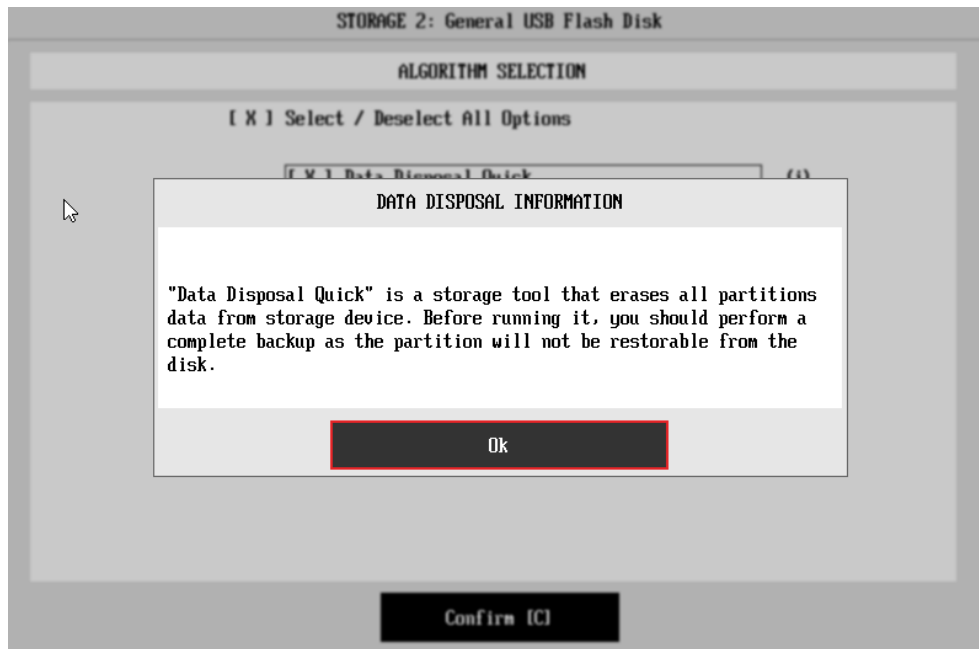


Figure 50: Data Disposal Quick Information

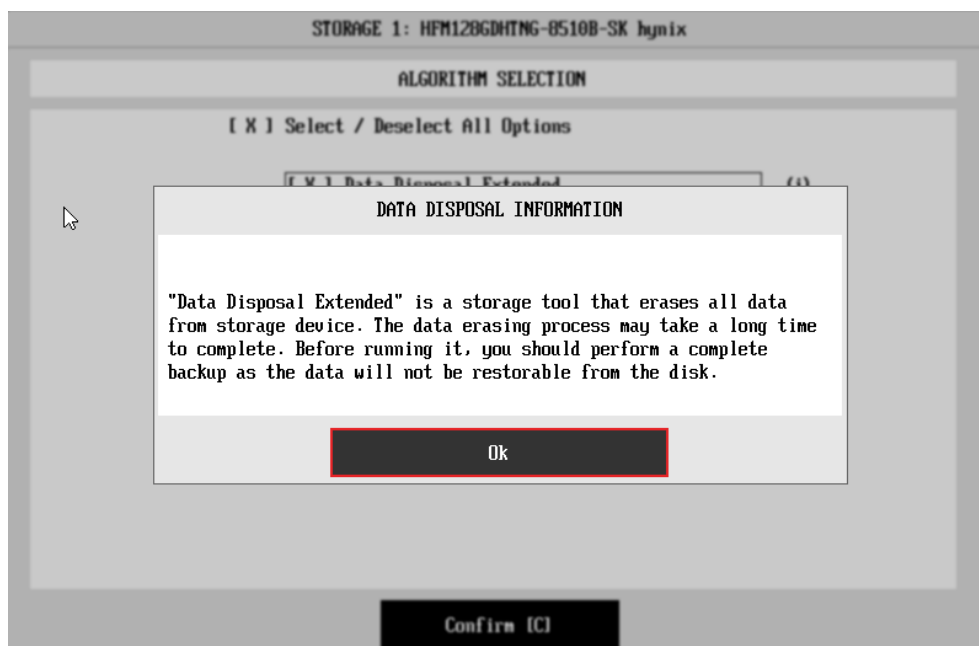


Figure 51: Data Disposal Full Information

Similar to the Bad Block Recovery tool, this tool follows an execution flow outlined in the “Executing Diagnostics” chapter. The user begins by selecting a device and then chooses the desired algorithm, either Quick or Full, if supported. Once everything is selected the execution can start, and before it starts a warning popup will appear. The user

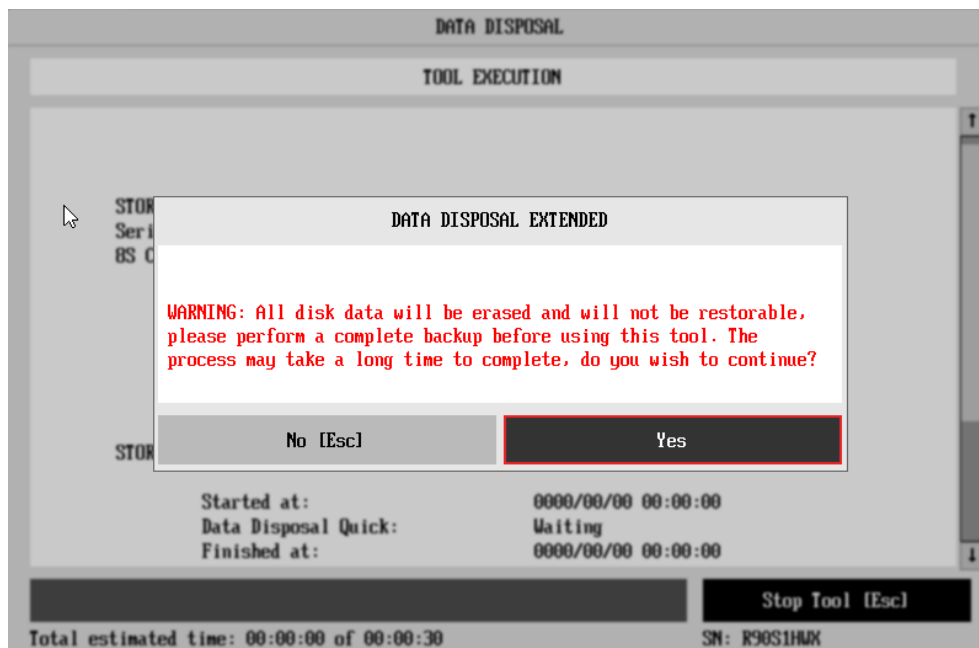


Figure 52: Data Disposal Full Information

8.1.5 SMART Information

The SMART Information tool provides insights into the hardware condition as reported by the S.M.A.R.T. (Self-Monitoring, Analysis, and Reporting Technology) monitoring system for HDDs, SSDs, and NVMe devices, helping to prevent imminent hardware failures.

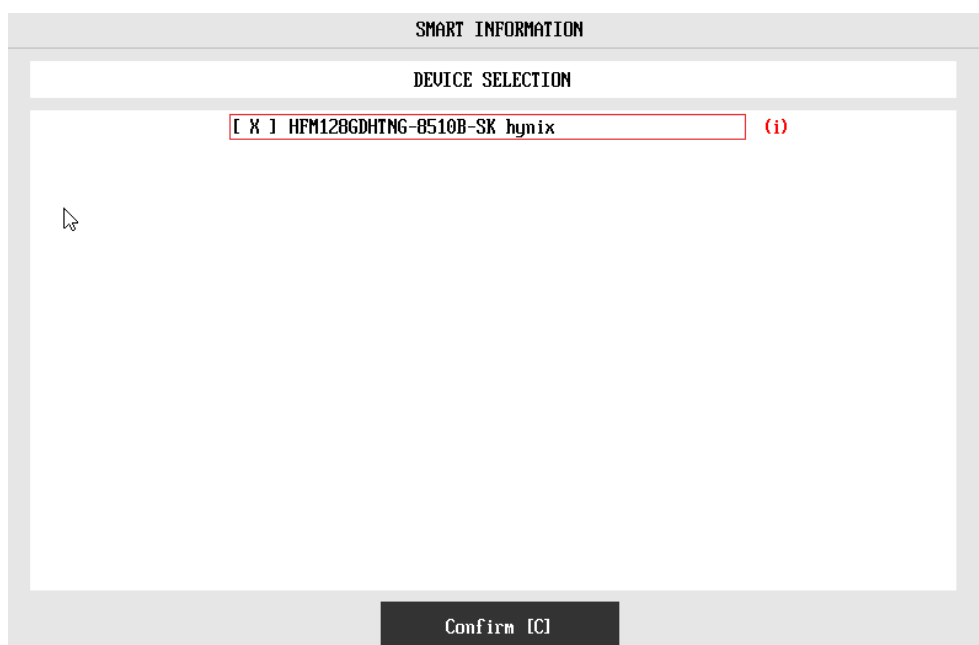


Figure 53: SMART Information Tool

SMART INFORMATION							
Displays SMART attributes and its values						Good	
ID	Name	Value	Threshold	Raw Value	Hex Raw	Status	
1	Read Error Rate	100	62	0	0	Good	↑
2	Throughput Performance	100	40	0	0	Good	
3	Spin-Up Time	223	33	64424509441	F00000001	Good	
4	Start/Stop Count	99	0	2027	7EB	Good	
5	Reallocated Sectors Count	100	5	0	0	Good	
7	Seek Error Rate	100	67	0	0	Good	
8	Seek Time Performance	100	40	0	0	Good	
9	Power-On Hours	96	0	1854	73E	Good	
10	Spin Retry Count	100	60	0	0	Good	
12	Power Cycle Count	99	0	1875	753	Good	↓
Refresh [R]				Export SMART Information [F2]			

Figure 54: SMART Information Tool

8.1.6 FAN Speed

The Ldiag UEFI Fan Speed tool allows users to control fan speed and visualize variations over time using a chart that plots Speed (RPM) against Time (in seconds). During the tool's operation, mouse and touch navigation will be disabled to avoid conflicts, so users must use a keyboard to proceed.

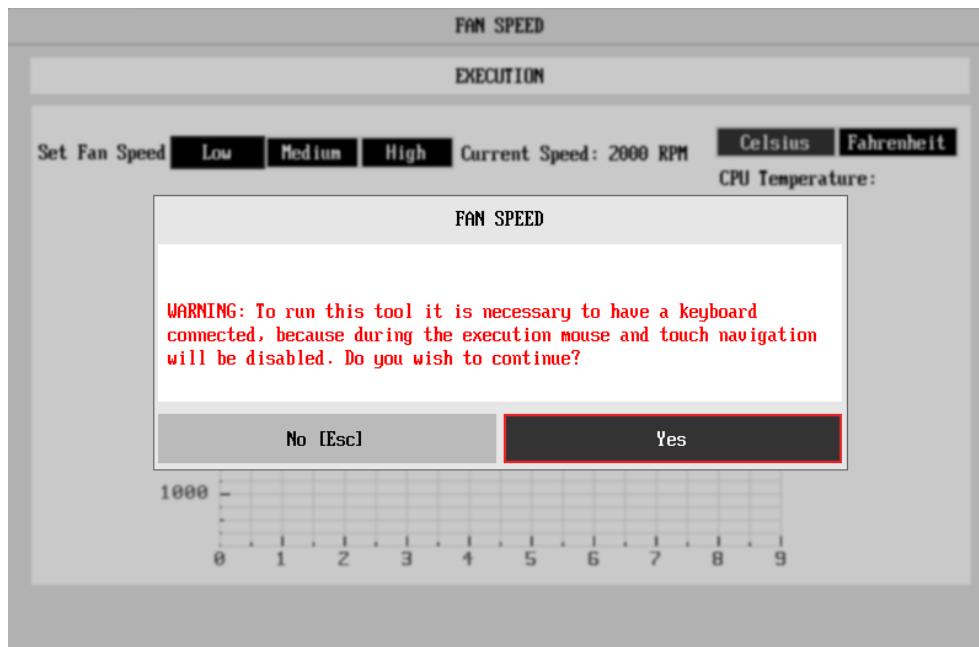


Figure 55: Fan Speed Warning

If the user consents to proceed, the Fan Speed Tool will begin monitoring fan behavior. Users can select from three different speed levels and choose between Celsius or Fahrenheit for temperature reporting.

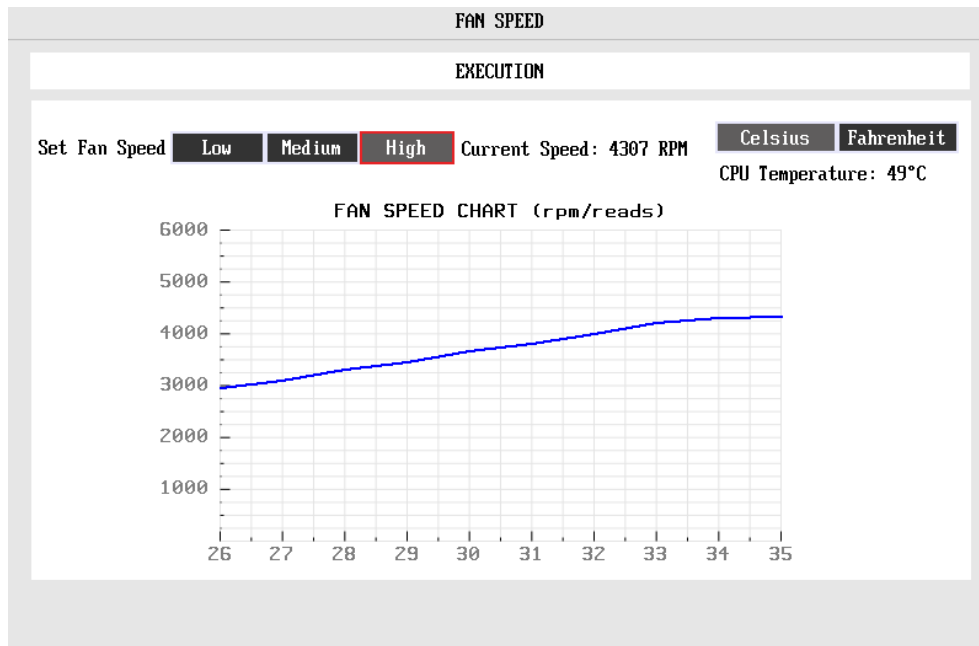


Figure 56: Fan Speed Tool

Users also have the option to export a CSV report by pressing the shortcut F2 or selecting the "Export Data" option. This exported file includes temperature readings in both Celsius and Fahrenheit over the duration of the tool's operation.

9 Features

This section outlines the various features available in the application, providing users with tools to enhance their experience and streamline operations.

9.1 Times to Run

The Times to Run feature allows users to run the same suite of diagnostics multiple times. It essentially repeats the selected diagnostics based on the number specified in the Times To Run section. This section can be found in the Algorithm Selection for standard modules and in the Run All section. The Run All configuration has a limit of 5 executions, while the maximum for standard modules is 50.

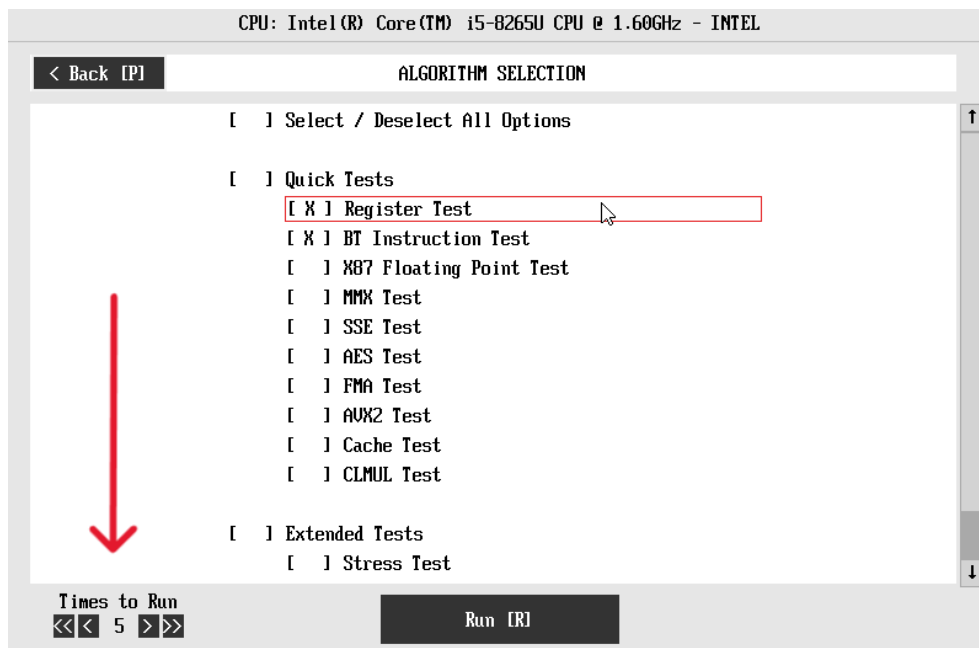


Figure 57: Times to Run - Module Configuration

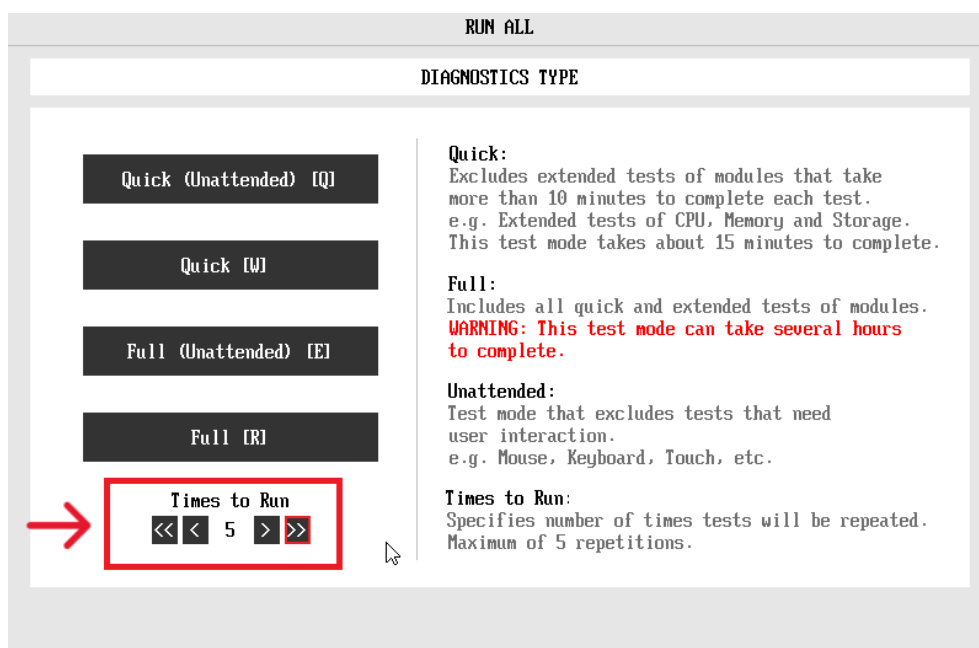


Figure 58: Times to Run - Run All Configuration

When the Times to Run is set to a value greater than one, the application will paginate the executions. Each execution of the suite will be displayed on a unique diagnostic screen, and each execution will have its own log and QR code.

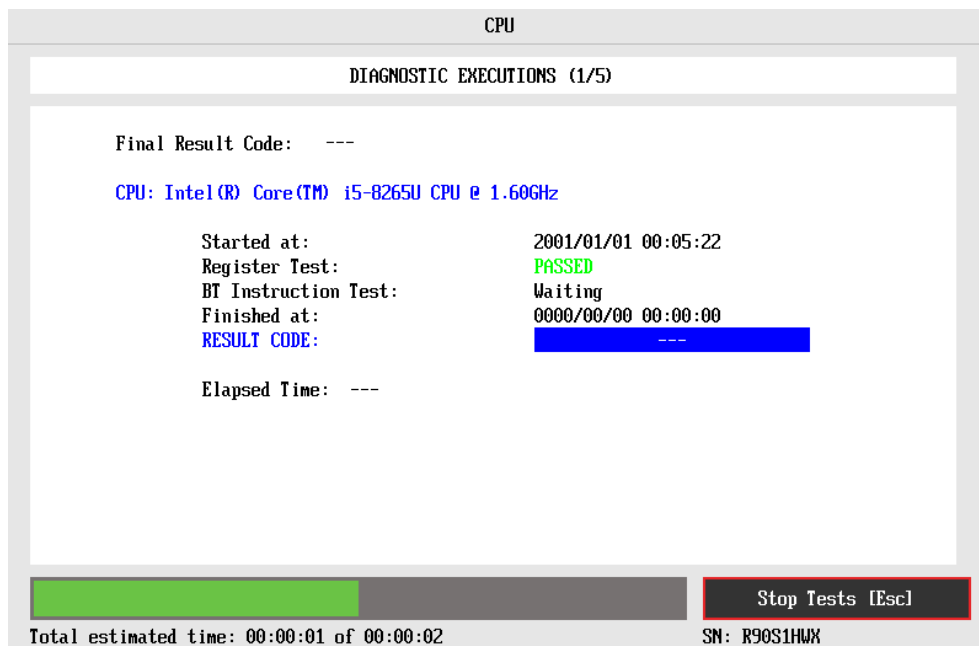


Figure 59: Times to Run Execution Screen

Users can navigate through the pages after the execution is complete using the ****Next (N)**** and ****Back (P)**** buttons to review the results of each run. On the log page, users can also browse through the logs for each execution.

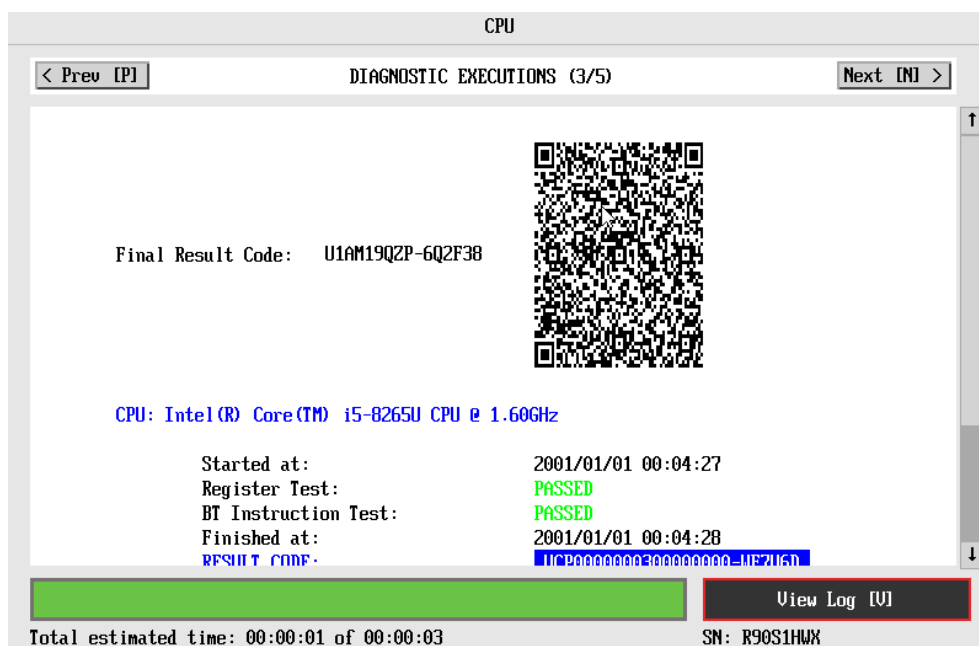


Figure 60: Times to Run Result Screen

Logs can be saved in two ways: users can save the specific log they are viewing to a file or export all concatenated execution logs into a single file. These options are available through the "Save" and "Save All" buttons, as shown in the placeholders below:

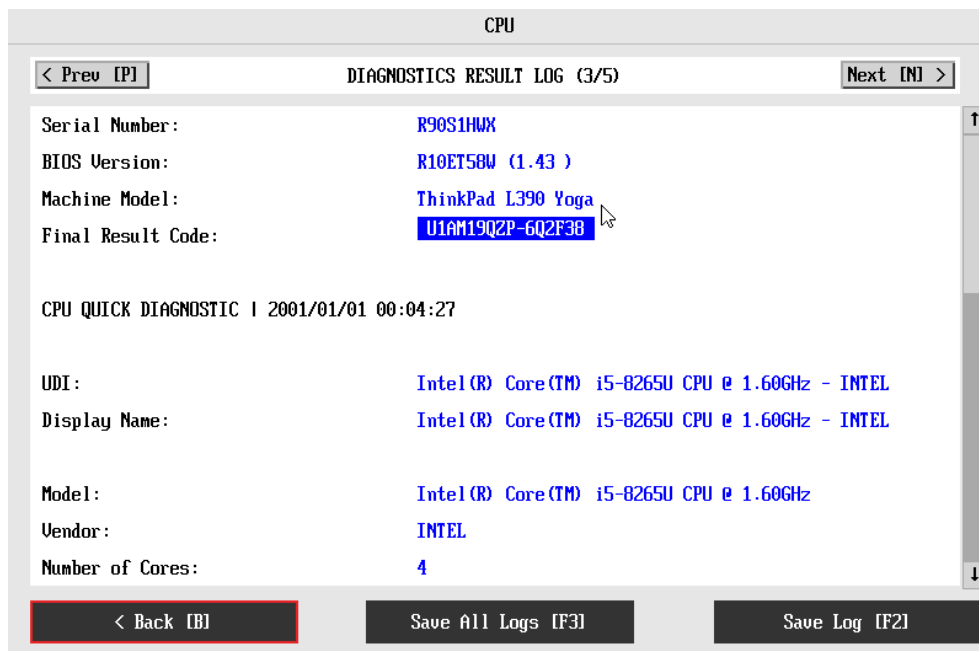


Figure 61: Times to Run View Log Screen

9.2 Screenshot Button

The Screenshot button is located in the application footer. Users can click the button or use the F11 shortcut to capture the current screen. This function saves the screenshot directly to the flash drive.



Figure 62: Screenshot Button

9.3 Help Button

The Help Button is a useful tool for users looking for guidance on specific information. This button is available on all screens of the application. For most screens, it mainly provides navigation tips, helping users understand how to move around the app, move focus, and select options.

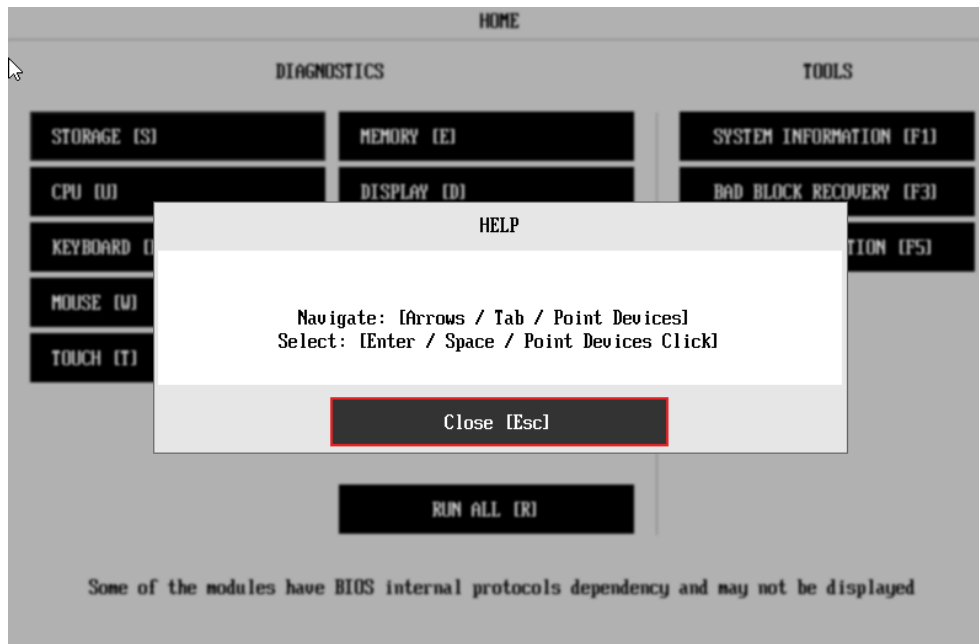


Figure 63: Help Popup

In addition to navigation assistance, the Help Button also offers context-specific information tailored to individual screens. For instance, when users click the Help Button on the algorithm selection screen, they receive essential details that aid in executing diagnostics effectively.



Figure 64: Help Popup

9.4 Hierarchical diagnostics

When a specific module fails during testing, the following message/question will be displayed, prompting the user to respond with either "No" or "Yes":

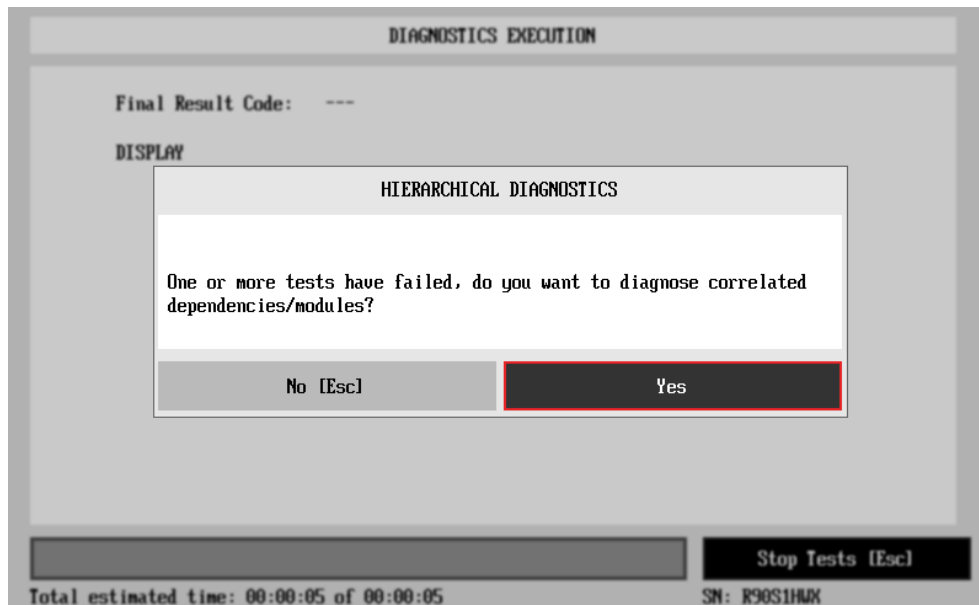


Figure 65: Hierarchical Popup

The hierarchical diagnostics feature executes tests in a structured manner, prioritizing more fundamental modules first. This functionality also facilitates the automatic identification of modules that may be the root cause of the failure when diagnosing a specific module. The example below illustrates the Hierarchical Diagnostics process for the Display Module:

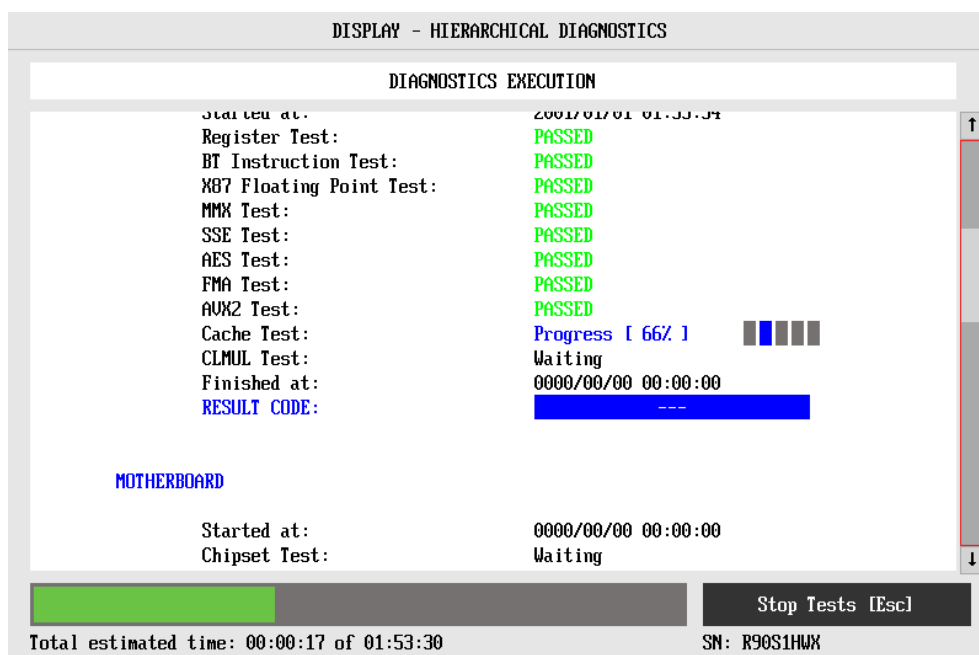


Figure 66: Hierarchical Execution

10 Exit the application

To exit the application, the user must select the option "Exit" on the Home screen and press the ENTER key. Then, the interface will be closed and the machine will be reset.

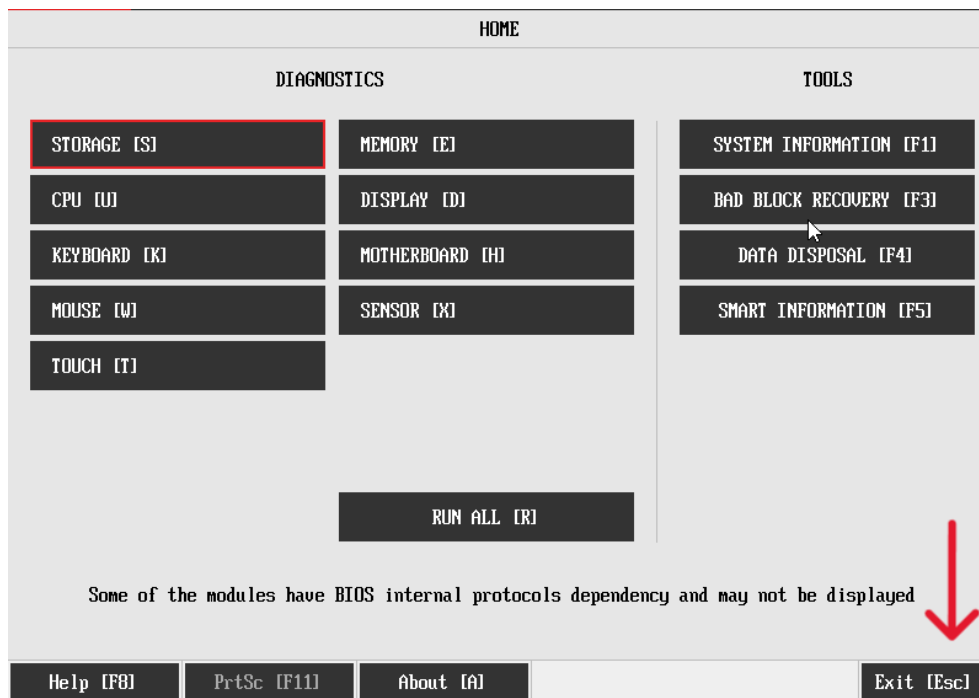


Figure 67: Button Exit

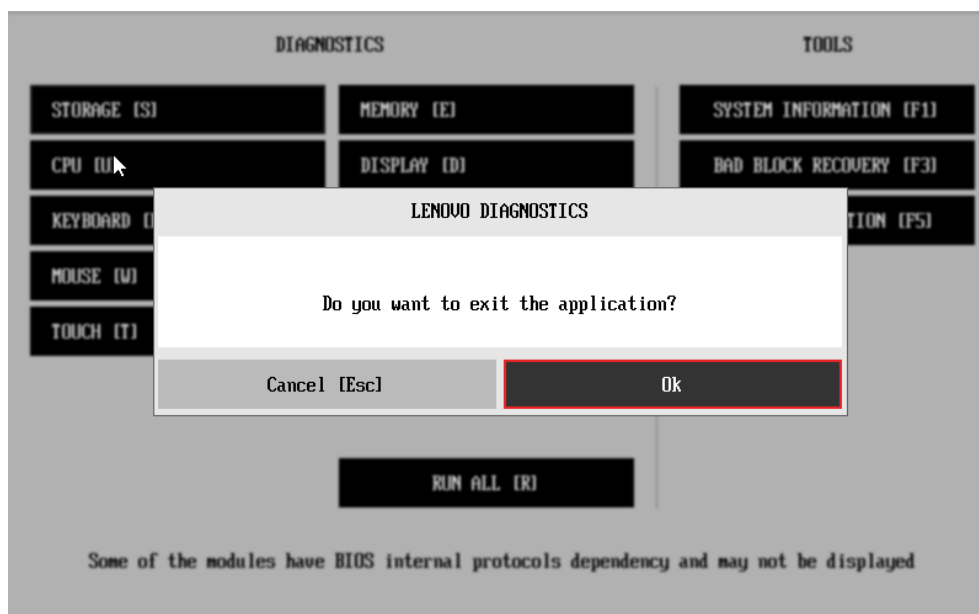


Figure 68: Exit Popup